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8-Bit µP Compatible A/D Converters Differential analog voltage inputs **General Description** The ADC0801, ADC0802, ADC0803, ADC0804 and

ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

ADC0805 are CMOS 8-bit successive approximation A/D converters that use a differential potentiometric ladder-similar to the 256R products. These converters are designed to allow operation with the NSC800 and INS8080A derivative control bus with TRI-STATE output latches directly driving the data bus. These A/Ds appear like memory locations or I/O ports to the microprocessor and no interfacing logic is needed.

Differential analog voltage inputs allow increasing the common-mode rejection and offsetting the analog zero input voltage value. In addition, the voltage reference input can be adjusted to allow encoding any smaller analog voltage span to the full 8 bits of resolution.

Features

- Compatible with 8080 µP derivatives—no interfacing logic needed - access time - 135 ns
- Easy interface to all microprocessors, or operates "stand alone"



- Logic inputs and outputs meet both MOS and TTL voltage level specifications
- Works with 2.5V (LM336) voltage reference
- On-chip clock generator
- OV to 5V analog input voltage range with single 5V supply
- No zero adjust required
- 0.3" standard width 20-pin DIP package
- 20-pin molded chip carrier or small outline package
- Operates ratiometrically or with 5 V_{DC}, 2.5 V_{DC}, or analog span adjusted voltage reference

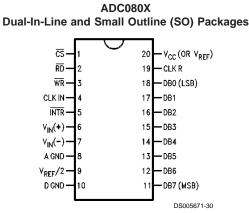
Key Specifications

- Resolution
- Total error
- Conversion time

±1⁄4 LSB,	±1⁄2 LSB	and	±1	LSB
			10)0 µs

8 bits

Connection Diagram





Ordering Information

	TEMP RANGE	0°C TO 70°C	0°C TO 70°C	–40°C TO +85°C
	±1/4 Bit Adjusted			ADC0801LCN
ERROR	±1/2 Bit Unadjusted	ADC0802LCWM		ADC0802LCN
	±1/2 Bit Adjusted			ADC0803LCN
	±1Bit Unadjusted	ADC0804LCWM	ADC0804LCN	ADC0805LCN/ADC0804LCJ
P/	PACKAGE OUTLINE		N20/	A-Molded DIP

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Typical Applications

ADC0801

ADC0802

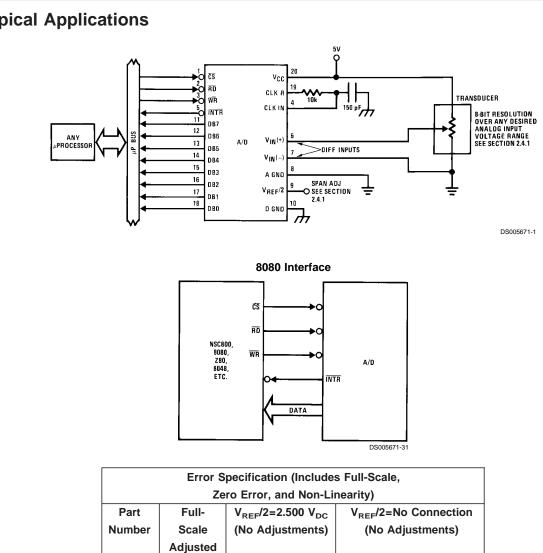
ADC0803

ADC0804

ADC0805

±1⁄4 LSB

±1/2 LSB



±1/2 LSB

±1 LSB

±1 LSB

Absolute Maximum Ratings (Notes 1, 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Supply Voltage (V _{CC}) (Note 3)	6.5V
Voltage	
Logic Control Inputs	-0.3V to +18V
At Other Input and Outputs	-0.3V to (V _{CC} +0.3V)
Lead Temp. (Soldering, 10 seconds)	
Dual-In-Line Package (plastic)	260°C
Dual-In-Line Package (ceramic)	300°C
Surface Mount Package	
Vapor Phase (60 seconds)	215°C

Infrared (15 seconds) $220^{\circ}C$ Storage Temperature Range $-65^{\circ}C$ to $+150^{\circ}C$ Package Dissipation at T_A=25°C875 mWESD Susceptibility (Note 10)800V

Operating Ratings (Notes 1, 2)

Temperature Range	T _{MIN} ≤T _A ≤T _{MAX}
ADC0804LCJ	–40°C≤T _A ≤+85°C
ADC0801/02/03/05LCN	–40°C≤T _A ≤+85°C
ADC0804LCN	0°C≤T _A ≤+70°C
ADC0802/04LCWM	0°C≤T _A ≤+70°C
Range of V_{CC}	4.5 V_{DC} to 6.3 V_{DC}

Electrical Characteristics

The following specifications apply for V_{CC} =5 V_{DC} , $T_{MIN} \le T_A \le T_{MAX}$ and f_{CLK} =640 kHz unless otherwise specified.

Parameter	Conditions	Min	Тур	Max	Units
ADC0801: Total Adjusted Error (Note 8)	With Full-Scale Adj.			±1⁄4	LSB
	(See Section 2.5.2)				
ADC0802: Total Unadjusted Error (Note 8)	V _{REF} /2=2.500 V _{DC}			±1/2	LSB
ADC0803: Total Adjusted Error (Note 8)	With Full-Scale Adj.			±1/2	LSB
	(See Section 2.5.2)				
ADC0804: Total Unadjusted Error (Note 8)	V _{REF} /2=2.500 V _{DC}			±1	LSB
ADC0805: Total Unadjusted Error (Note 8)	V _{REF} /2-No Connection			±1	LSB
V _{REF} /2 Input Resistance (Pin 9)	ADC0801/02/03/05	2.5	8.0		kΩ
	ADC0804 (Note 9)	0.75	1.1		kΩ
Analog Input Voltage Range	(Note 4) V(+) or V(-)	Gnd-0.05		V _{cc} +0.05	V _{DC}
DC Common-Mode Error	Over Analog Input Voltage		±1/16	±1⁄8	LSB
	Range				
Power Supply Sensitivity	V _{CC} =5 V _{DC} ±10% Over		±1/16	±1⁄8	LSB
	Allowed $V_{IN}(+)$ and $V_{IN}(-)$				
	Voltage Range (Note 4)				

AC Electrical Characteristics

The following specifications apply for V_{CC}=5 V_{DC} and T_{MIN} \leq T_A \leq T_{MAX} unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
T _C	Conversion Time	f _{CLK} =640 kHz (Note 6)	103		114	μs
T _C	Conversion Time	(Notes 5, 6)	66		73	1/f _{CLK}
f _{CLK}	Clock Frequency	V _{CC} =5V, (Note 5)	100	640	1460	kHz
	Clock Duty Cycle		40		60	%
CR	Conversion Rate in Free-Running	INTR tied to WR with	8770		9708	conv/s
	Mode	$\overline{\text{CS}}$ =0 V _{DC} , f _{CLK} =640 kHz				
t _{W(WR)L}	Width of WR Input (Start Pulse Width)	$\overline{\text{CS}} = 0 \text{ V}_{\text{DC}} \text{ (Note 7)}$	100			ns
t _{ACC}	Access Time (Delay from Falling	C _L =100 pF		135	200	ns
	Edge of RD to Output Data Valid)					
t _{1H} , t _{0H}	TRI-STATE Control (Delay	C _L =10 pF, R _L =10k		125	200	ns
	from Rising Edge of RD to	(See TRI-STATE Test				
	Hi-Z State)	Circuits)				
t _{WI} , t _{RI}	Delay from Falling Edge			300	450	ns
	of WR or RD to Reset of INTR					
CIN	Input Capacitance of Logic			5	7.5	pF
	Control Inputs					

ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

AC Electrical Characteristics (Continued)

The following specifications apply for V_{CC}=5 V_{DC} and T_{MIN} \leq T_A \leq T_{MAX} unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
C _{OUT}	TRI-STATE Output			5	7.5	pF
	Capacitance (Data Buffers)					
CONTROL I	INPUTS [Note: CLK IN (Pin 4) is the input of a	a Schmitt trigger circuit and is the	erefore sp	ecified se	parately]	
V _{IN} (1)	Logical "1" Input Voltage	V_{CC} =5.25 V_{DC}	2.0		15	V_{DC}
	(Except Pin 4 CLK IN)					
V _{IN} (0)	Logical "0" Input Voltage	V_{CC} =4.75 V_{DC}			0.8	V_{DC}
	(Except Pin 4 CLK IN)					
I _{IN} (1)	Logical "1" Input Current	V _{IN} =5 V _{DC}		0.005	1	μA _{DC}
	(All Inputs)					
I _{IN} (0)	Logical "0" Input Current	V _{IN} =0 V _{DC}	-1	-0.005		μΑ _{DC}
	(All Inputs)					
CLOCK IN /	AND CLOCK R					
V _T +	CLK IN (Pin 4) Positive Going		2.7	3.1	3.5	V_{DC}
	Threshold Voltage					
V _T -	CLK IN (Pin 4) Negative		1.5	1.8	2.1	V _{DC}
	Going Threshold Voltage					
V _H	CLK IN (Pin 4) Hysteresis		0.6	1.3	2.0	V _{DC}
	$(V_T+)-(V_T-)$					
V _{OUT} (0)	Logical "0" CLK R Output	I _O =360 μA			0.4	V _{DC}
	Voltage	V_{CC} =4.75 V_{DC}				
V _{OUT} (1)	Logical "1" CLK R Output	I _O =–360 μA	2.4			V _{DC}
	Voltage	V_{CC} =4.75 V_{DC}				
DATA OUT	PUTS AND INTR		1			
V _{оит} (0)	Logical "0" Output Voltage					
	Data Outputs	I_{OUT} =1.6 mA, V_{CC} =4.75 V_{DC}			0.4	V_{DC}
	INTR Output	I_{OUT} =1.0 mA, V_{CC} =4.75 V_{DC}			0.4	V_{DC}
V _{OUT} (1)	Logical "1" Output Voltage	I _O =-360 μA, V _{CC} =4.75 V _{DC}	2.4			V _{DC}
V _{OUT} (1)	Logical "1" Output Voltage	I _O =-10 μA, V _{CC} =4.75 V _{DC}	4.5			V _{DC}
I _{OUT}	TRI-STATE Disabled Output	V _{OUT} =0 V _{DC}	-3			μA _{DC}
	Leakage (All Data Buffers)	V _{OUT} =5 V _{DC}			3	μA_{DC}
ISOURCE		V _{OUT} Short to Gnd, T _A =25°C	4.5	6		mA _{DC}
I _{SINK}		V _{OUT} Short to V _{CC} , T _A =25°C	9.0	16		mA _{DC}
POWER SU	PPLY		1		1	
I _{cc}	Supply Current (Includes	f _{CLK} =640 kHz,				
-	Ladder Current)	V _{REF} /2=NC, T _A =25°C				
		and $\overline{CS} = 5V$				
	ADC0801/02/03/04LCJ/05			1.1	1.8	mA
	ADC0804LCN/LCWM			1.9	2.5	mA

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. DC and AC electrical specifications do not apply when operating the device beyond its specified operating conditions.

Note 2: All voltages are measured with respect to Gnd, unless otherwise specified. The separate A Gnd point should always be wired to the D Gnd.

Note 3: A zener diode exists, internally, from V_{CC} to Gnd and has a typical breakdown voltage of 7 V_{DC} .

Note 4: For V_{IN}(-) ≥ V_{IN}(+) the digital output code will be 0000 0000. Two on-chip diodes are tied to each analog input (see block diagram) which will forward conduct for analog input voltages one diode drop below ground or one diode drop greater than the V_{CC} supply. Be careful, during testing at low V_{CC} levels (4.5V), as high level analog inputs (5V) can cause this input diode to conduct-especially at elevated temperatures, and cause errors for analog inputs near full-scale. The spec allows 50 mV forward bias of either diode. This means that as long as the analog V_{IN} does not exceed the supply voltage by more than 50 mV, the output code will be correct. To achieve an absolute 0 V_{DC} to 5 V_{DC} input voltage range will therefore require a minimum supply voltage of 4.950 V_{DC} over temperature variations, initial tolerance and loading.

Note 5: Accuracy is guaranteed at f_{CLK} = 640 kHz. At higher clock frequencies accuracy can degrade. For lower clock frequencies, the duty cycle limits can be extended so long as the minimum clock high time interval or minimum clock low time interval is no less than 275 ns.

Note 6: With an asynchronous start pulse, up to 8 clock periods may be required before the internal clock phases are proper to start the conversion process. The start request is internally latched, see Figure 4 and section 2.0.

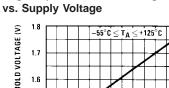
ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

AC Electrical Characteristics (Continued)

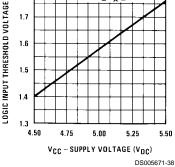
Note 7: The CS input is assumed to bracket the WR strobe input and therefore timing is dependent on the WR pulse width. An arbitrarily wide pulse width will hold the converter in a reset mode and the start of conversion is initiated by the low to high transition of the WR pulse (see timing diagrams).

Note 8: None of these A/Ds requires a zero adjust (see section 2.5.1). To obtain zero code at other analog input voltages see section 2.5 and Figure 7. Note 9: The V_{REF}/2 pin is the center point of a two-resistor divider connected from V_{CC} to ground. In all versions of the ADC0801, ADC0802, ADC0803, and ADC0805, and in the ADC0804LCJ, each resistor is typically 16 kp. In all versions of the ADC0804 except the ADC0804LCJ, each resistor is typically 2.2 kp. Note 10: Human body model, 100 pF discharged through a 1.5 k Ω resistor.

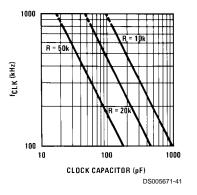
Typical Performance Characteristics



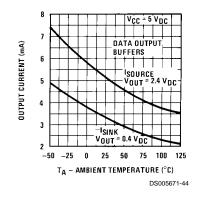
Logic Input Threshold Voltage

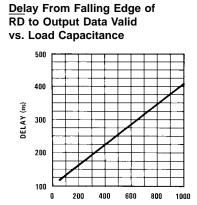


f_{CLK} vs. Clock Capacitor



Output Current vs Temperature

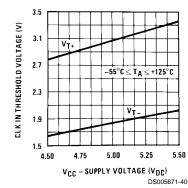




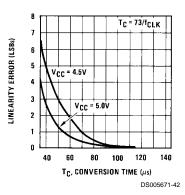
LOAD CAPACITANCE (pF)

DS005671-39

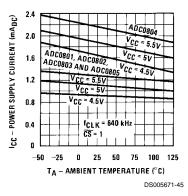
CLK IN Schmitt Trip Levels vs. Supply Voltage

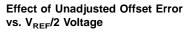


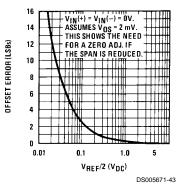
Full-Scale Error vs **Conversion Time**



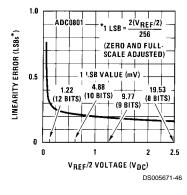


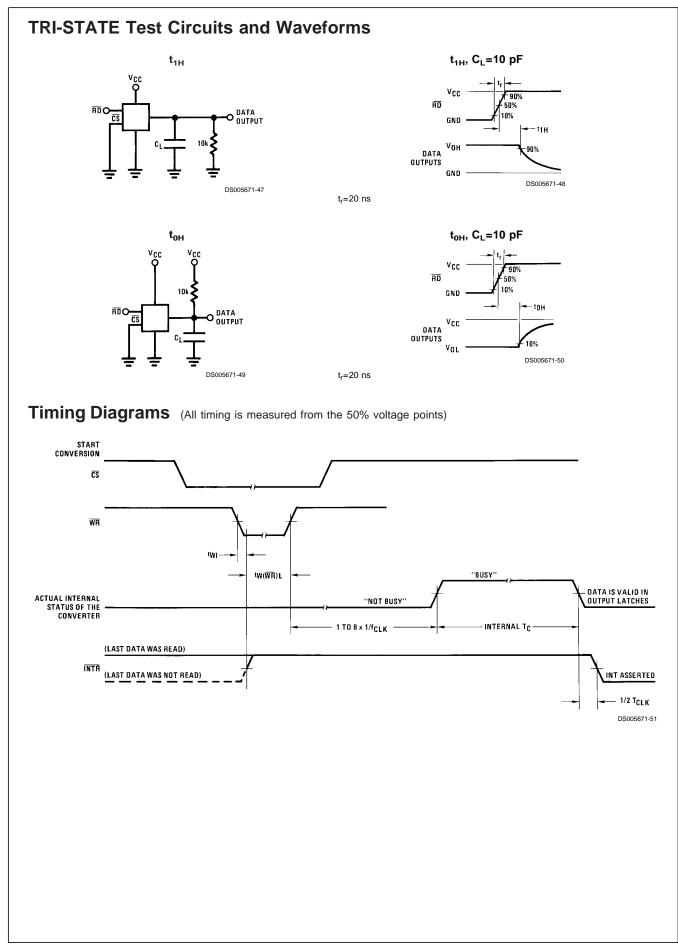






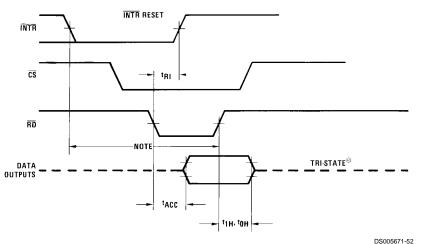
Linearity Error at Low V_{REF}/2 Voltages





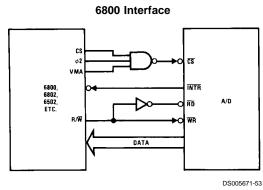
Timing Diagrams (All timing is measured from the 50% voltage points) (Continued)

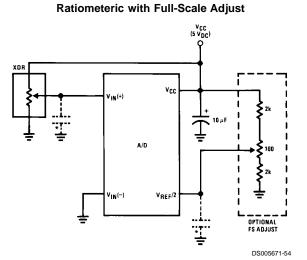




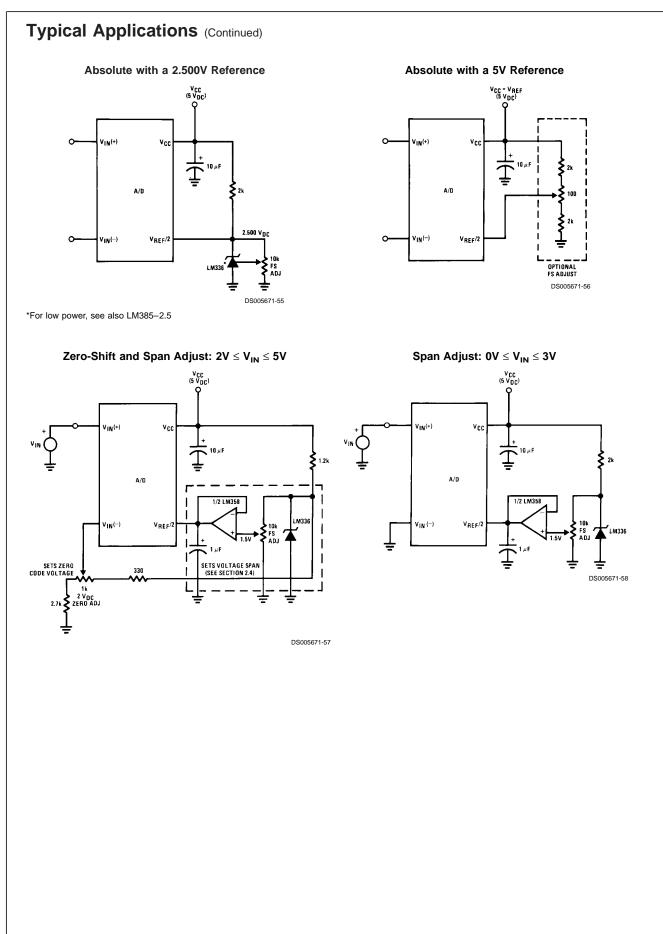
Note: Read strobe must occur 8 clock periods (8/ f_{CLK}) after assertion of interrupt to guarantee reset of $\overline{\text{INTR}}$.

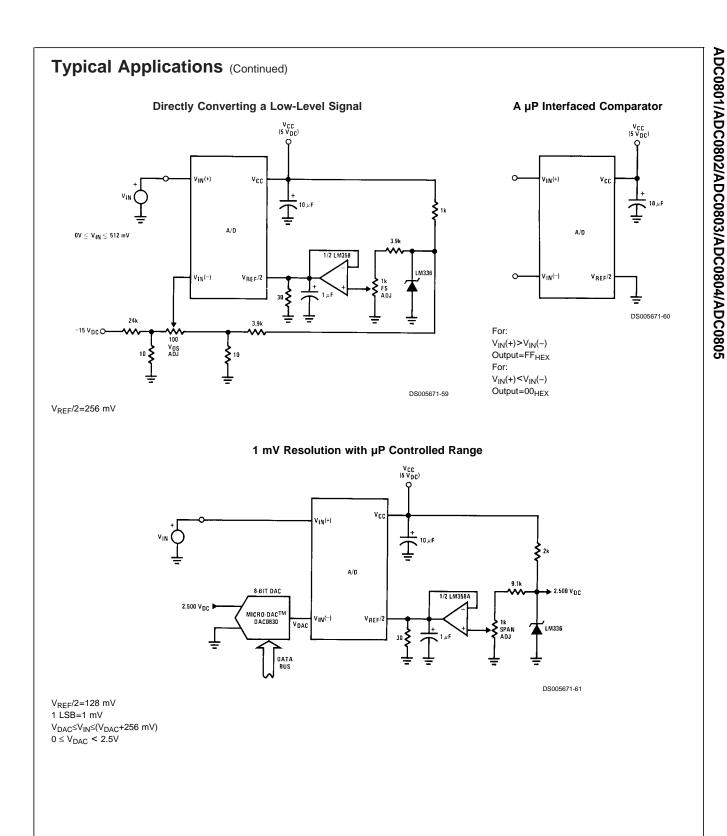
Typical Applications

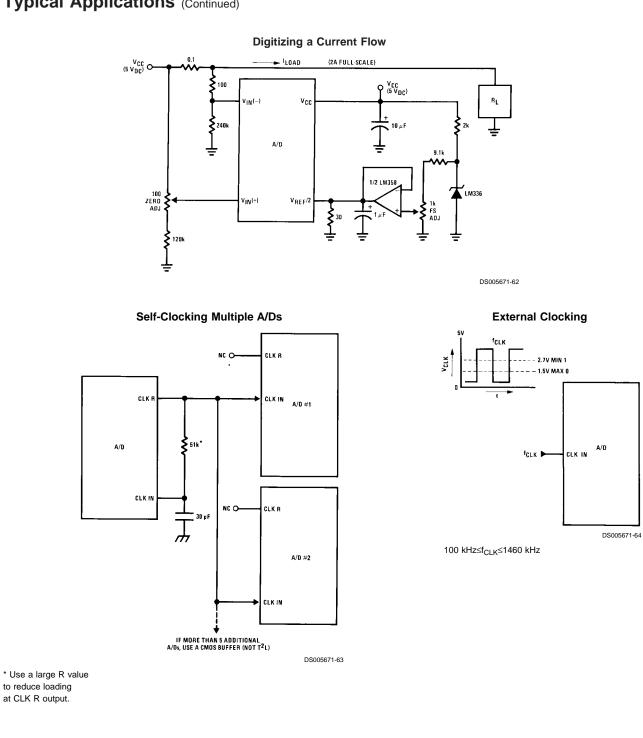




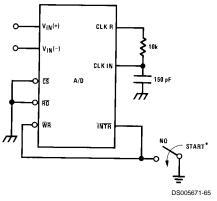
Note: before using caps at V_{IN} or V_{REF}/2, see section 2.3.2 Input Bypass Capacitors.





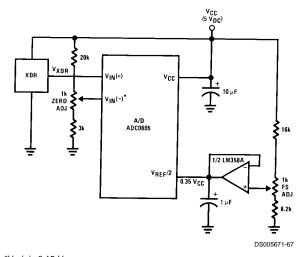


Self-Clocking in Free-Running Mode

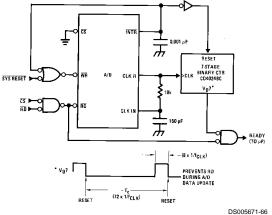


*After power-up, a momentary grounding of the $\overline{\text{WR}}$ input is needed to guarantee operation.

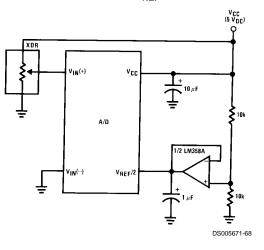
Operating with "Automotive" Ratiometric Transducers







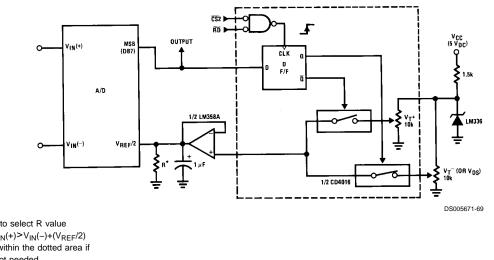
Ratiometric with V_{REF}/2 Forced



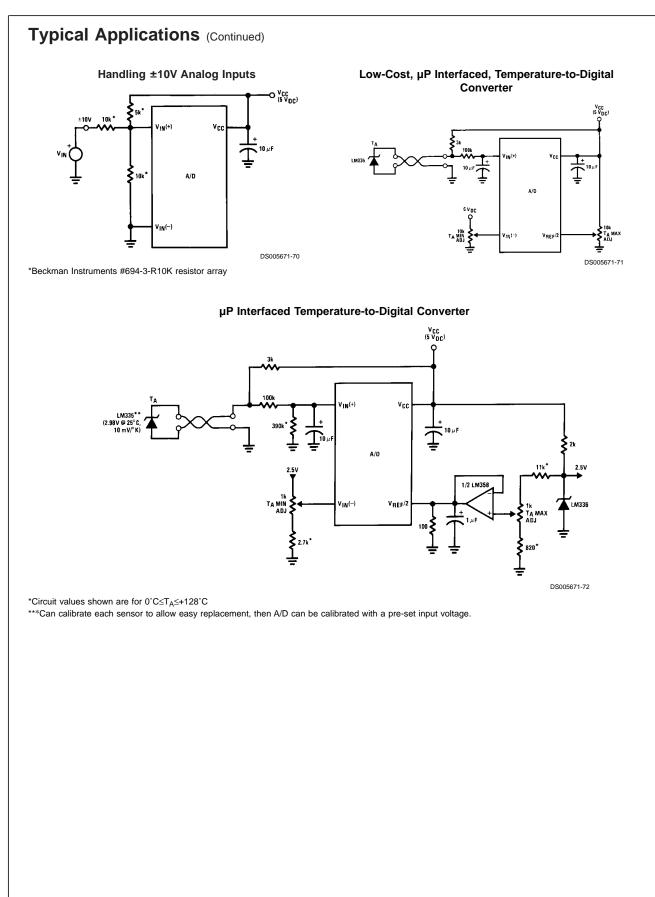
ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

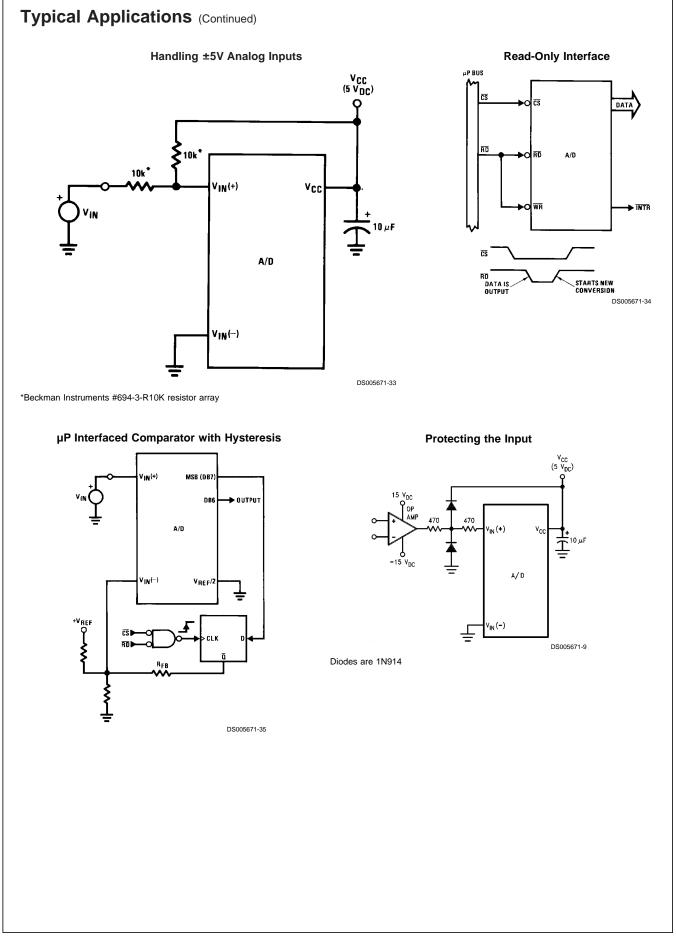
*V_{IN}(-)=0.15 V_{CC} 15% of V_{CC} \leq V_{XDR} \leq 85% of V_{CC}

µP Compatible Differential-Input Comparator with Pre-Set Vos (with or without Hysteresis)

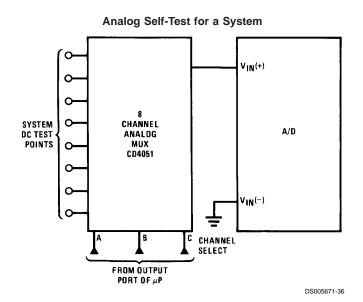


*See Figure 5 to select R value DB7="1" for $V_{IN}(+) > V_{IN}(-) + (V_{REF}/2)$ Omit circuitry within the dotted area if hysteresis is not needed

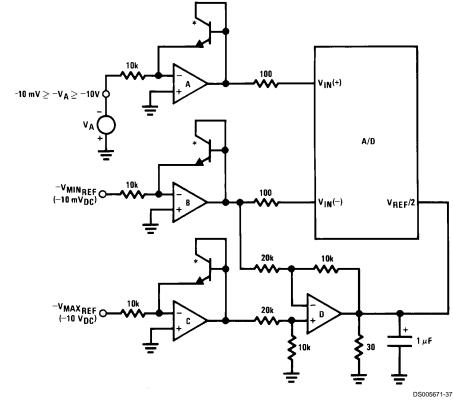




ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

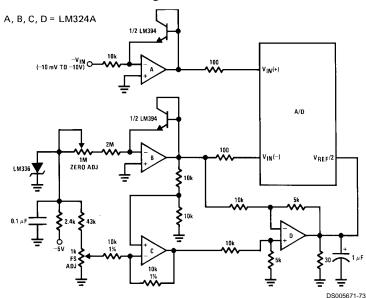


A Low-Cost, 3-Decade Logarithmic Converter

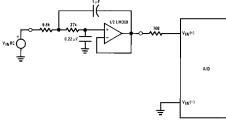


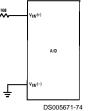
*LM389 transistors A, B, C, D = LM324A quad op amp

3-Decade Logarithmic A/D Converter



Noise Filtering the Analog Input



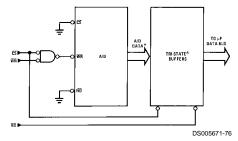


f_C=20 Hz

Uses Chebyshev implementation for steeper roll-off unity-gain, 2nd order, low-pass filter

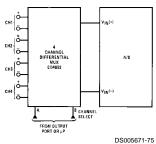
Adding a separate filter for each channel increases system response time if an analog multiplexer is used

Output Buffers with A/D Data Enabled

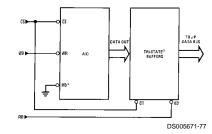


*A/D output data is updated 1 CLK period prior to assertion of $\overline{\text{INTR}}$

Multiplexing Differential Inputs

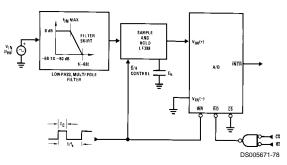


Increasing Bus Drive and/or Reducing Time on Bus



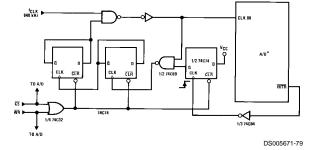
*Allows output data to set-up at falling edge of $\overline{\text{CS}}$

Sampling an AC Input Signal



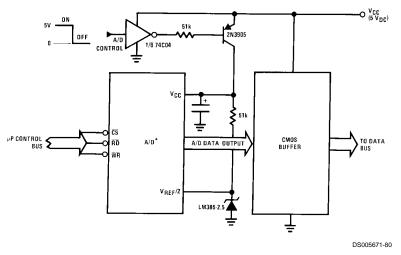
Note 11: Oversample whenever possible [keep fs > 2f(-60)] to eliminate input frequency folding (aliasing) and to allow for the skirt response of the filter. **Note 12:** Consider the amplitude errors which are introduced within the passband of the filter.

70% Power Savings by Clock Gating



(Complete shutdown takes \approx 30 seconds.)

Power Savings by A/D and V_{REF} Shutdown



*Use ADC0801, 02, 03 or 05 for lowest power consumption. Note: Logic inputs can be driven to V_{CC} with A/D supply at zero volts. Buffer prevents data bus from overdriving output of A/D when in shutdown mode.

Functional Description

1.0 UNDERSTANDING A/D ERROR SPECS

A perfect A/D transfer characteristic (staircase waveform) is shown in *Figure 1*. The horizontal scale is analog input voltage and the particular points labeled are in steps of 1 LSB (19.53 mV with 2.5V tied to the $V_{REF}/2$ pin). The digital output codes that correspond to these inputs are shown as

D-1, D, and D+1. For the perfect A/D, not only will center-value (A-1, A, A+1,) analog inputs produce the correct output digital codes, but also each riser (the transitions between adjacent output codes) will be located $\pm 1/2$ LSB away from each center-value. As shown, the risers are ideal and have no width. Correct digital output codes will be provided for a range of analog input voltages that extend

 $\pm \frac{1}{2}$ LSB from the ideal center-values. Each tread (the range of analog input voltage that provides the same digital output code) is therefore 1 LSB wide.

Figure 2 shows a worst case error plot for the ADC0801. All center-valued inputs are guaranteed to produce the correct output codes and the adjacent risers are guaranteed to be no closer to the center-value points than $\pm 1/4$ LSB. In other words, if we apply an analog input equal to the center-value $\pm 1/4$ LSB, *we guarantee* that the A/D will produce the correct digital code. The maximum range of the position of the code transition is indicated by the horizontal arrow and it is guaranteed to be no more than 1/2 LSB.

The error curve of *Figure 3* shows a worst case error plot for the ADC0802. Here we guarantee that if we apply an analog input equal to the LSB analog voltage center-value the A/D will produce the correct digital code.

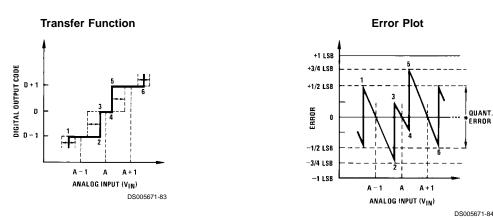
DIGITAL OUTPUT CODE

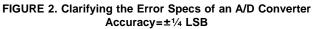
Next to each transfer function is shown the corresponding error plot. Many people may be more familiar with error plots than transfer functions. The analog input voltage to the A/D is provided by either a linear ramp or by the discrete output steps of a high resolution DAC. Notice that the error is continuously displayed and includes the quantization uncertainty of the A/D. For example the error at point 1 of *Figure 1* is +1/2 LSB because the digital code appeared 1/2 LSB in advance of the center-value of the tread. The error plots always have a constant negative slope and the abrupt upside steps are always 1 LSB in magnitude.

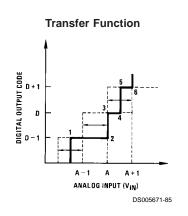
DS005671-82

Transfer Function Error Plot +1 LSE D +1/2 LSE п ERROR QUANT. D -- 1 -1/2 LSE A – 1 A Δ + 1 -1 LSB ANALOG INPUT (VIN) A – 1 Α A + 1 DS005671-81 ANALOG INPUT (VIN)

FIGURE 1. Clarifying the Error Specs of an A/D Converter Accuracy=±0 LSB: A Perfect A/D







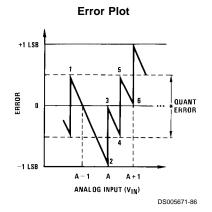


FIGURE 3. Clarifying the Error Specs of an A/D Converter Accuracy=±1/2 LSB

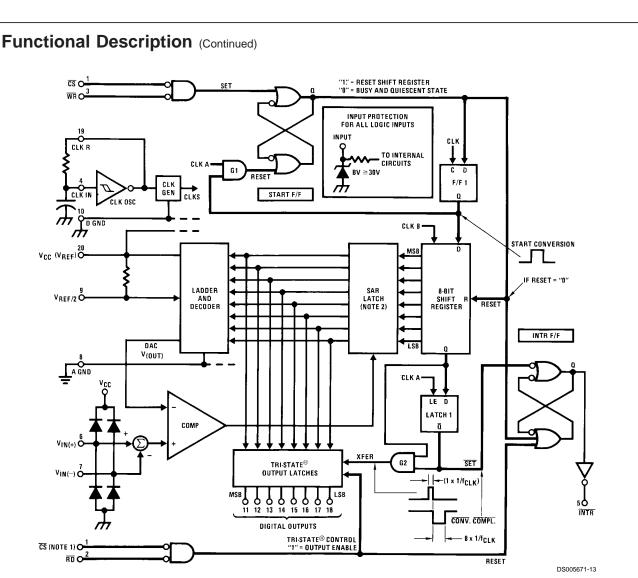
2.0 FUNCTIONAL DESCRIPTION

The ADC0801 series contains a circuit equivalent of the 256R network. Analog switches are sequenced by successive approximation logic to match the analog difference input voltage [V_{IN}(+) – V_{IN}(-)] to a corresponding tap on the R network. The most significant bit is tested first and after 8 comparisons (64 clock cycles) a digital 8-bit binary code (1111 1111 = full-scale) is transferred to an output latch and then an interrupt is asserted (INTR makes a high-to-low transition). A conversion in process can be interrupted by issuing a second start command. The device may be operated in the free-running mode by connecting INTR to the WR input with \overline{CS} =0. To ensure start-up under all possible conditions, an external WR pulse is required during the first power-up cycle.

On the high-to-low transition of the \overline{WR} input the internal SAR latches and the shift register stages are reset. As long as the \overline{CS} input and \overline{WR} input remain low, the A/D will remain in a reset state. Conversion will start from 1 to 8 clock periods after at least one of these inputs makes a low-to-high transition.

A functional diagram of the A/D converter is shown in *Figure* 4. All of the package pinouts are shown and the major logic control paths are drawn in heavier weight lines.

The converter is started by having \overline{CS} and \overline{WR} simultaneously low. This sets the start flip-flop (F/F) and the resulting "1" level resets the 8-bit shift register, resets the Interrupt (INTR) F/F and inputs a "1" to the D flop, F/F1, which is at the input end of the 8-bit shift register. Internal clock signals then transfer this "1" to the Q output of F/F1. The AND gate, G1, combines this "1" output with a clock signal to provide a reset signal to the start F/F. If the set signal is no longer present (either \overline{WR} or \overline{CS} is a "1") the start F/F is reset and the 8-bit shift register then can have the "1" clocked in, which starts the conversion process. If the set signal were to still be present, this reset pulse would have no effect (both outputs of the start F/F would momentarily be at a "1" level) and the 8-bit shift register would continue to be held in the reset mode. This logic therefore allows for wide \overline{CS} and \overline{WR} signals and the converter will start after at least one of these signals returns high and the internal clocks again provide a reset signal for the start F/F.



Note 13: \overline{CS} shown twice for clarity. **Note 14:** SAR = Successive Approximation Register.

FIGURE 4. Block Diagram

After the "1" is clocked through the 8-bit shift register (which completes the SAR search) it appears as the input to the D-type latch, LATCH 1. As soon as this "1" is output from the shift register, the AND gate, G2, causes the new digital word to transfer to the TRI-STATE output latches. When LATCH 1 is subsequently enabled, the Q output makes a high-to-low transition which causes the INTR F/F to set. An inverting buffer then supplies the INTR input signal.

Note that this SET control of the INTR F/F remains low for 8 of the external clock periods (as the internal clocks run at ½ of the frequency of the external clock). If the data output is continuously enabled (CS and RD both held low), the INTR output will still signal the end of conversion (by a high-to-low transition), because the SET input can control the Q output of the INTR F/F even though the RESET input is constantly at a "1" level in this operating mode. This INTR output will therefore stay low for the duration of the SET signal, which is 8 periods of the external clock frequency (assuming the A/D is not started during this interval).

When operating in the free-running or continuous conversion mode ($\overline{\text{INTR}}$ pin tied to $\overline{\text{WR}}$ and $\overline{\text{CS}}$ wired low—see also section 2.8), the START F/F is SET by the high-to-low transition of the $\overline{\text{INTR}}$ signal. This resets the SHIFT REGISTER

which causes the input to the D-type latch, LATCH 1, to go low. As the latch enable input is still present, the \overline{Q} output will go high, which then allows the INTR F/F to be RESET. This reduces the width of the resulting \overline{INTR} output pulse to only a few propagation delays (approximately 300 ns).

When data is to be read, the combination of both \overline{CS} and \overline{RD} being low will cause the INTR F/F to be reset and the TRI-STATE output latches will be enabled to provide the 8-bit digital outputs.

2.1 Digital Control Inputs

The digital control inputs (\overline{CS} , \overline{RD} , and \overline{WR}) meet standard T²L logic voltage levels. These signals have been renamed when compared to the standard A/D Start and Output Enable labels. In addition, these inputs are active low to allow an easy interface to microprocessor control busses. For non-microprocessor based applications, the \overline{CS} input (pin 1) can be grounded and the standard A/D Start function is obtained by an active low pulse applied at the \overline{WR} input (pin 3) and the Output Enable function is caused by an active low pulse at the \overline{RD} input (pin 2).

2.2 Analog Differential Voltage Inputs and Common-Mode Rejection

This A/D has additional applications flexibility due to the analog differential voltage input. The V_{IN}(–) input (pin 7) can be used to automatically subtract a fixed voltage value from the input reading (tare correction). This is also useful in 4 mA–20 mA current loop conversion. In addition, common-mode noise can be reduced by use of the differential input.

The time interval between sampling V_{IN}(+) and V_{IN}(-) is 4-1/₂ clock periods. The maximum error voltage due to this slight time difference between the input voltage samples is given by:

$$\Delta V_{e}(MAX) = (V_{P}) (2\pi f_{CM}) \left(\frac{4.5}{f_{CLK}}\right)$$

where:

 ΔV_e is the error voltage due to sampling delay

 V_{P} is the peak value of the common-mode voltage

f_{cm} is the common-mode frequency

As an example, to keep this error to 1/4 LSB (~5 mV) when operating with a 60 Hz common-mode frequency, f_{cm}, and using a 640 kHz A/D clock, f_{CLK}, would allow a peak value of the common-mode voltage, V_P, which is given by:

$$\mathsf{V}_{\mathsf{P}} = \frac{[\Delta \mathsf{V}_{\mathsf{e}(\mathsf{MAX})} (\mathsf{f}_{\mathsf{CLK}})]}{(2\pi \mathsf{f}_{\mathsf{Cm}}) (4.5)}$$

or

$$I_{\rm P} = rac{(5 imes 10^{-3}) (640 imes 10^3)}{(6.28) (60) (4.5)}$$

which gives

V_P≃1.9V.

The allowed range of analog input voltages usually places more severe restrictions on input common-mode noise levels.

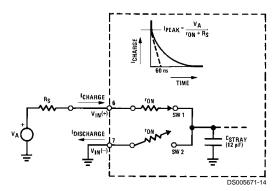
An analog input voltage with a reduced span and a relatively large zero offset can be handled easily by making use of the differential input (see section 2.4 Reference Voltage).

2.3 Analog Inputs

2.3 1 Input Current

Normal Mode

Due to the internal switching action, displacement currents will flow at the analog inputs. This is due to on-chip stray capacitance to ground as shown in *Figure 5*.



 $r_{ON} \text{ of SW 1 and SW 2} \simeq 5 \text{ } \text{k}\Omega$ $r=r_{ON} C_{STRAY} \simeq 5 \text{ } \text{k}\Omega \text{ x 12 pF} = 60 \text{ ns}$

FIGURE 5. Analog Input Impedance

The voltage on this capacitance is switched and will result in currents entering the $V_{IN}(+)$ input pin and leaving the $V_{IN}(-)$ input which will depend on the analog differential input voltage levels. These current transients occur at the leading edge of the internal clocks. They rapidly decay and *do not cause errors* as the on-chip comparator is strobed at the end of the clock period.

Fault Mode

If the voltage source applied to the V_{IN}(+) or V_{IN}(-) pin exceeds the allowed operating range of V_{CC}+50 mV, large input currents can flow through a parasitic diode to the V_{CC} pin. If these currents can exceed the 1 mA max allowed spec, an external diode (1N914) should be added to bypass this current to the V_{CC} pin (with the current bypassed with this diode, the voltage at the V_{IN}(+) pin can exceed the V_{CC} voltage by the forward voltage of this diode).

2.3.2 Input Bypass Capacitors

Bypass capacitors at the inputs will average these charges and cause a DC current to flow through the output resistances of the analog signal sources. This charge pumping action is worse for continuous conversions with the $V_{IN}(+)$ input voltage at full-scale. For continuous conversions with a 640 kHz clock frequency with the V_{IN}(+) input at 5V, this DC current is at a maximum of approximately 5 µA. Therefore, bypass capacitors should not be used at the analog inputs or the $V_{REF}/2$ pin for high resistance sources (> 1 k Ω). If input bypass capacitors are necessary for noise filtering and high source resistance is desirable to minimize capacitor size, the detrimental effects of the voltage drop across this input resistance, which is due to the average value of the input current, can be eliminated with a full-scale adjustment while the given source resistor and input bypass capacitor are both in place. This is possible because the average value of the input current is a precise linear function of the differential input voltage.

2.3.3 Input Source Resistance

Large values of source resistance where an input bypass capacitor is not used, *will not cause errors* as the input currents settle out prior to the comparison time. If a low pass filter is required in the system, use a low valued series resistor ($\leq 1 \ k\Omega$) for a passive RC section or add an op amp RC active low pass filter. For low source resistance applications, ($\leq 1 \ k\Omega$), a 0.1 µF bypass capacitor at the inputs will prevent noise pickup due to series lead inductance of a long

ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

Functional Description (Continued)

wire. A 100Ω series resistor can be used to isolate this capacitor—both the R and C are placed outside the feedback loop—from the output of an op amp, if used.

2.3.4 Noise

The leads to the analog inputs (pins 6 and 7) should be kept as short as possible to minimize input noise coupling. Both noise and undesired digital clock coupling to these inputs can cause system errors. The source resistance for these inputs should, in general, be kept below 5 k Ω . Larger values of source resistance can cause undesired system noise pickup. Input bypass capacitors, placed from the analog inputs to ground, will eliminate system noise pickup but can create analog scale errors as these capacitors will average the transient input switching currents of the A/D (see section 2.3.1.). This scale error depends on both a large source resistance and the use of an input bypass capacitor. This error can be eliminated by doing a full-scale adjustment of the A/D (adjust V_{REF}/2 for a proper full-scale reading-see section 2.5.2 on Full-Scale Adjustment) with the source resistance and input bypass capacitor in place.

2.4 Reference Voltage

2.4.1 Span Adjust

For maximum applications flexibility, these A/Ds have been designed to accommodate a 5 V_{DC} , 2.5 V_{DC} or an adjusted voltage reference. This has been achieved in the design of the IC as shown in *Figure 6*.

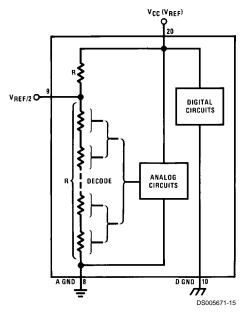


FIGURE 6. The V_{REFERENCE} Design on the IC

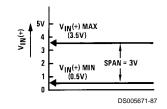
Notice that the reference voltage for the IC is either $^{1}\!\!/_{2}$ of the voltage applied to the V_{CC} supply pin, or is equal to the voltage that is externally forced at the $V_{REF}/2$ pin. This allows for a ratiometric voltage reference using the V_{CC} supply, a 5 V_{DC} reference voltage can be used for the V_{CC} supply or a voltage less than 2.5 V_{DC} can be applied to the $V_{REF}/2$ input for increased application flexibility. The internal gain to the $V_{REF}/2$ input is 2, making the full-scale differential input voltage twice the voltage at pin 9.

An example of the use of an adjusted reference voltage is to accommodate a reduced span — or dynamic voltage range of the analog input voltage. If the analog input voltage were to range from 0.5 V_{DC} to 3.5 V_{DC} , instead of 0V to 5 V_{DC} , the span would be 3V as shown in *Figure 7*. With 0.5 V_{DC} applied to the $V_{\rm IN}(-)$ pin to absorb the offset, the reference voltage can be made equal to $1\!/_2$ of the 3V span or 1.5 V_{DC} . The A/D now will encode the $V_{\rm IN}(+)$ signal from 0.5V to 3.5 V with the 0.5V input corresponding to zero and the 3.5 V_{DC} input corresponding to full-scale. The full 8 bits of resolution are therefore applied over this reduced analog input voltage range.

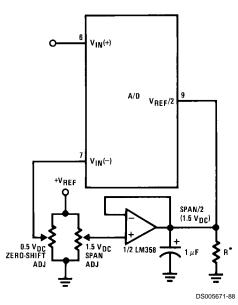
2.4.2 Reference Accuracy Requirements

The converter can be operated in a ratiometric mode or an absolute mode. In ratiometric converter applications, the magnitude of the reference voltage is a factor in both the output of the source transducer and the output of the A/D converter and therefore cancels out in the final digital output code. The ADC0805 is specified particularly for use in ratiometric applications with no adjustments required. In absolute conversion applications, both the initial value and the temperature stability of the reference voltage are important factors in the accuracy of the A/D converter. For V_{RFF}/2 voltages of 2.4 V_{DC} nominal value, initial errors of ±10 mV_{DC} will cause conversion errors of ±1 LSB due to the gain of 2 of the VREF/2 input. In reduced span applications, the initial value and the stability of the V_{RFF}/2 input voltage become even more important. For example, if the span is reduced to 2.5V, the analog input LSB voltage value is correspondingly reduced from 20 mV (5V span) to 10 mV and 1 LSB at the $V_{\text{REF}}/2$ input becomes 5 mV. As can be seen, this reduces the allowed initial tolerance of the reference voltage and requires correspondingly less absolute change with temperature variations. Note that spans smaller than 2.5V place even tighter requirements on the initial accuracy and stability of the reference source.

In general, the magnitude of the reference voltage will require an initial adjustment. Errors due to an improper value of reference voltage appear as full-scale errors in the A/D transfer function. IC voltage regulators may be used for references if the ambient temperature changes are not excessive. The LM336B 2.5V IC reference diode (from National Semiconductor) has a temperature stability of 1.8 mV typ (6 mV max) over 0°C≤T_A≤+70°C. Other temperature range parts are also available.



a) Analog Input Signal Example



*Add if $V_{REF}/2 \le 1 V_{DC}$ with LM358 to draw 3 mA to ground.

b) Accommodating an Analog Input from 0.5V (Digital Out = 00_{HEX}) to 3.5V (Digital Out=FF_{HEX})



2.5 Errors and Reference Voltage Adjustments

2.5.1 Zero Error

The zero of the A/D does not require adjustment. If the minimum analog input voltage value, V_{IN(MIN)}, is not ground, a zero offset can be done. The converter can be made to output 0000 0000 digital code for this minimum input voltage by biasing the A/D V_{IN}(–) input at this V_{IN(MIN)} value (see Applications section). This utilizes the differential mode operation of the A/D.

The zero error of the A/D converter relates to the location of the first riser of the transfer function and can be measured by grounding the V_{IN} (-) input and applying a small magnitude positive voltage to the V_{IN} (+) input. Zero error is the difference between the actual DC input voltage that is necessary to just cause an output digital code transition from 0000 0000 to 0000 0001 and the ideal ½ LSB value (½ LSB = 9.8 mV for V_{REF}/2=2.500 V_{DC}).

2.5.2 Full-Scale

The full-scale adjustment can be made by applying a differential input voltage that is 1½ LSB less than the desired analog full-scale voltage range and then adjusting the magnitude of the $V_{REF}/2$ input (pin 9 or the V_{CC} supply if pin 9 is not used) for a digital output code that is just changing from 1111 1110 to 1111 1111.

2.5.3 Adjusting for an Arbitrary Analog Input Voltage Range

If the analog zero voltage of the A/D is shifted away from ground (for example, to accommodate an analog input signal that does not go to ground) this new zero reference should be properly adjusted first. A V_{IN}(+) voltage that equals this desired zero reference plus $\frac{1}{2}$ LSB (where the LSB is calculated for the desired analog span, 1 LSB=analog span/

256) is applied to pin 6 and the zero reference voltage at pin 7 should then be adjusted to just obtain the 00_{HEX} to 01_{HEX} code transition.

The full-scale adjustment should then be made (with the proper V_{IN}(-) voltage applied) by forcing a voltage to the V_{IN}(+) input which is given by:

$$V_{IN}$$
 (+) fs adj = V_{MAX} -1.5 $\left[\frac{(V_{MAX} - V_{MIN})}{256}\right]$

where:

 V_{MAX} =The high end of the analog input range

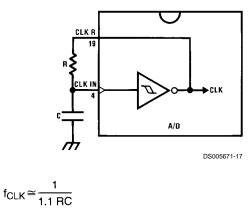
and

 V_{MIN} =the low end (the offset zero) of the analog range. (Both are ground referenced.)

The V_{REF}/2 (or V_{CC}) voltage is then adjusted to provide a code change from FE_{HEX} to FF_{HEX}. This completes the adjustment procedure.

2.6 Clocking Option

The clock for the A/D can be derived from the CPU clock or an external RC can be added to provide self-clocking. The CLK IN (pin 4) makes use of a Schmitt trigger as shown in *Figure 8.*



 $R \cong 10 \ k\Omega$

FIGURE 8. Self-Clocking the A/D

Heavy capacitive or DC loading of the clock R pin should be avoided as this will disturb normal converter operation. Loads less than 50 pF, such as driving up to 7 A/D converter clock inputs from a single clock R pin of 1 converter, are allowed. For larger clock line loading, a CMOS or low power TTL buffer or PNP input logic should be used to minimize the loading on the clock R pin (do not use a standard TTL buffer).

2.7 Restart During a Conversion

If the A/D is restarted (\overline{CS} and \overline{WR} go low and return high) during a conversion, the converter is reset and a new conversion is started. The output data latch is not updated if the conversion in process is not allowed to be completed, therefore the data of the previous conversion remains in this latch. The INTR output simply remains at the "1" level.

2.8 Continuous Conversions

For operation in the free-running mode an initializing pulse should be used, following power-up, to ensure circuit operation. In this application, the $\overline{\text{CS}}$ input is grounded and the $\overline{\text{WR}}$ input is tied to the $\overline{\text{INTR}}$ output. This $\overline{\text{WR}}$ and $\overline{\text{INTR}}$ node should be momentarily forced to logic low following a power-up cycle to guarantee operation.

2.9 Driving the Data Bus

This MOS A/D, like MOS microprocessors and memories, will require a bus driver when the total capacitance of the data bus gets large. Other circuitry, which is tied to the data bus, will add to the total capacitive loading, even in TRI-STATE (high impedance mode). Backplane bussing also greatly adds to the stray capacitance of the data bus.

There are some alternatives available to the designer to handle this problem. Basically, the capacitive loading of the data bus slows down the response time, even though DC specifications are still met. For systems operating with a relatively slow CPU clock frequency, more time is available in which to establish proper logic levels on the bus and therefore higher capacitive loads can be driven (see typical characteristics curves).

At higher CPU clock frequencies time can be extended for I/O reads (and/or writes) by inserting wait states (8080) or using clock extending circuits (6800).

Finally, if time is short and capacitive loading is high, external bus drivers must be used. These can be TRI-STATE buffers

(low power Schottky such as the DM74LS240 series is recommended) or special higher drive current products which are designed as bus drivers. High current bipolar bus drivers with PNP inputs are recommended.

2.10 Power Supplies

Noise spikes on the V_{CC} supply line can cause conversion errors as the comparator will respond to this noise. A low inductance tantalum filter capacitor should be used close to the converter V_{CC} pin and values of 1 μ F or greater are recommended. If an unregulated voltage is available in the system, a separate LM340LAZ-5.0, TO-92, 5V voltage regulator for the converter (and other analog circuitry) will greatly reduce digital noise on the V_{CC} supply.

2.11 Wiring and Hook-Up Precautions

Standard digital wire wrap sockets are not satisfactory for breadboarding this A/D converter. Sockets on PC boards can be used and all logic signal wires and leads should be grouped and kept as far away as possible from the analog signal leads. Exposed leads to the analog inputs can cause undesired digital noise and hum pickup, therefore shielded leads may be necessary in many applications.

A single point analog ground that is separate from the logic ground points should be used. The power supply bypass capacitor and the self-clocking capacitor (if used) should both be returned to digital ground. Any $V_{REF}/2$ bypass capacitors, analog input filter capacitors, or input signal shielding should be returned to the analog ground point. A test for proper grounding is to measure the zero error of the A/D converter. Zero errors in excess of $\frac{1}{4}$ LSB can usually be traced to improper board layout and wiring (see section 2.5.1 for measuring the zero error).

3.0 TESTING THE A/D CONVERTER

There are many degrees of complexity associated with testing an A/D converter. One of the simplest tests is to apply a known analog input voltage to the converter and use LEDs to display the resulting digital output code as shown in *Figure 9*. For ease of testing, the $V_{REF}/2$ (pin 9) should be supplied with 2.560 V_{DC} and a V_{CC} supply voltage of 5.12 V_{DC} should be used. This provides an LSB value of 20 mV.

If a full-scale adjustment is to be made, an analog input voltage of 5.090 V_{DC} (5.120–1½ LSB) should be applied to the V_{IN}(+) pin with the V_{IN}(-) pin grounded. The value of the V_{REF}/2 input voltage should then be adjusted until the digital output code is just changing from 1111 1110 to 1111 1111. This value of V_{REF}/2 should then be used for all the tests.

The digital output LED display can be decoded by dividing the 8 bits into 2 hex characters, the 4 most significant (MS) and the 4 least significant (LS). *Table 1* shows the fractional binary equivalent of these two 4-bit groups. By adding the voltages obtained from the "VMS" and "VLS" columns in *Table 1*, the nominal value of the digital display (when $V_{REF}/2 = 2.560V$) can be determined. For example, for an output LED display of 1011 0110 or B6 (in hex), the voltage values from the table are 3.520 + 0.120 or $3.640 V_{DC}$. These voltage values represent the center-values of a perfect A/D converter. The effects of quantization error have to be accounted for in the interpretation of the test results.

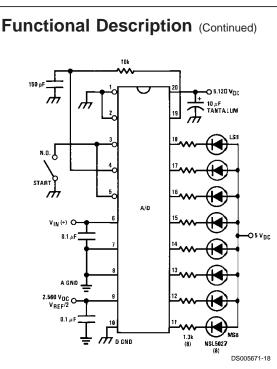


FIGURE 9. Basic A/D Tester

For a higher speed test system, or to obtain plotted data, a digital-to-analog converter is needed for the test set-up. An accurate 10-bit DAC can serve as the precision voltage source for the A/D. Errors of the A/D under test can be expressed as either analog voltages or differences in 2 digital words.

A basic A/D tester that uses a DAC and provides the error as an analog output voltage is shown in *Figure 8*. The 2 op amps can be eliminated if a lab DVM with a numerical subtraction feature is available to read the difference voltage, "A–C", directly. The analog input voltage can be supplied by a low frequency ramp generator and an X-Y plotter can be used to provide analog error (Y axis) versus analog input (X axis).

For operation with a microprocessor or a computer-based test system, it is more convenient to present the errors digitally. This can be done with the circuit of *Figure 11*, where the output code transitions can be detected as the 10-bit DAC is incremented. This provides 1/4 LSB steps for the 8-bit A/D under test. If the results of this test are automatically plotted with the analog input on the X axis and the error (in LSB's) as the Y axis, a useful transfer function of the A/D under test results. For acceptance testing, the plot is not necessary and the testing speed can be increased by establishing internal limits on the allowed error for each code.

4.0 MICROPROCESSOR INTERFACING

To dicuss the interface with 8080A and 6800 microprocessors, a common sample subroutine structure is used. The microprocessor starts the A/D, reads and stores the results of 16 successive conversions, then returns to the user's program. The 16 data bytes are stored in 16 successive memory locations. All Data and Addresses will be given in hexadecimal form. Software and hardware details are provided separately for each type of microprocessor.

4.1 Interfacing 8080 Microprocessor Derivatives (8048, 8085)

This converter has been designed to directly interface with derivatives of the 8080 microprocessor. The A/D can be mapped into memory space (using standard memory address decoding for CS and the MEMR and MEMW strobes) or it can be controlled as an I/O device by using the I/O R and I/O W strobes and decoding the address bits A0 \rightarrow A7 (or address bits A8 \rightarrow A15 as they will contain the same 8-bit address information) to obtain the CS input. Using the I/O space provides 256 additional addresses and may allow a simpler 8-bit address decoder but the data can only be input to the accumulator. To make use of the additional memory reference instructions, the A/D should be mapped into memory space. An example of an A/D in I/O space is shown in *Figure 12*.

Functional Description (Continued)																
ANALOG INPUT VOLTAGE (A) VOLTAGE (A) VOLTAGE (A) VOLTAGE (A) (A) (A) (A) (A) (A) (A) (A) (A) (A)																
					FI	GURE 10	. A/D Test	er with Analog Err	or Outp							
					DIGITAL		DAC1000 10-BIT DAC	A/D UNDER TEST		DIGITAL OUTPUT						
						FIGUE	RE 11. Ba	sic "Digital" A/D Te	ester	DS005671-90						
					ТА	BLE 1. DI	TABLE 1. DECODING THE DIGITAL OUTPUT LEDS									
FRACTIONAL BINARY VALUE FOR OUTPUT VOLTAGE CENTER VALUES																
HEX		BIN	ARY			FRAC	CTIONAL	BINARY VALUE FC	DR		CENTER					
HEX		BIN	ARY			FRAC		BINARY VALUE FC	DR		CENTER WI	VALUES				
HEX		BIN	ARY		MS	FRAC		BINARY VALUE FO			CENTER WI	VALUES ITH				
HEX F	1	BIN <i>,</i>	ARY	1	MS	GROUP			ROUP	15/256	CENTER WI V _{REF} /2=2 VMS GROUP (Note 15) 4.800	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300				
F	1	1	1	0	MS		15/16				CENTER WI V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280				
F E D	1	1 1 1	1 1 0	0 1		5 GROUP 7/8		LS GI	ROUP	15/256	CENTER WI V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.160	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260				
F E D C	1 1 1	1 1 1	1 1 0 0	0 1 0	MS 3/4	5 GROUP 7/8	15/16 13/16		ROUP	13/256	CENTER WI V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.160 3.840	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240				
F E D C B	1 1 1	1 1 1 1 0	1 1 0 0	0 1 0 1		3 GROUP 7/8	15/16	LS GI	ROUP 7/128		CENTER Wi V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.480 4.160 3.840 3.520	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.280 0.260 0.240 0.220				
F E D C B A	1 1 1 1	1 1 1 1 0 0	1 1 0 0 1 1	0 1 0 1 0		5 GROUP 7/8	15/16 13/16 11/16	LS GI	ROUP	13/256	CENTER WI V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.480 4.160 3.840 3.520 3.200	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.220 0.200				
F E D C B A 9	1 1 1 1 1 1	1 1 1 1 0 0 0	1 1 0 0 1 1 0	0 1 0 1 0 1	3/4	3 GROUP 7/8	15/16 13/16	LS GF 3/64	ROUP 7/128	13/256	CENTER WI V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.160 3.840 3.520 3.200 2.880	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.200 0.180				
F E D C B A	1 1 1 1	1 1 1 1 0 0	1 1 0 0 1 1	0 1 0 1 0		3 GROUP 7/8	15/16 13/16 11/16	LS GI	ROUP 7/128	13/256	CENTER WI V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.480 4.160 3.840 3.520 3.200	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.220 0.200				
F E D C B A 9 8	1 1 1 1 1 1 1	1 1 1 0 0 0 0	1 1 0 0 1 1 0 0	0 1 0 1 0 1 0	3/4	3 GROUP 7/8	15/16 13/16 11/16 9/16	LS GF 3/64	ROUP 7/128	13/256 11/256 9/256	CENTER Wi V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.160 3.840 3.520 3.200 2.880 2.560	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.220 0.200 0.180 0.160				
F E D C B A 9 8 7	1 1 1 1 1 1 1 0	1 1 1 0 0 0 0 0	1 1 0 1 1 0 0 0	0 1 0 1 0 1 0 1	3/4	5 GROUP 7/8 5/8	15/16 13/16 11/16 9/16	LS GF 3/64	7/128 5/128	13/256 11/256 9/256	CENTER Wi V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.480 4.160 3.840 3.520 3.200 2.880 2.560 2.240	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.220 0.200 0.180 0.160 0.140				
F E D C B A 9 8 7 6	1 1 1 1 1 1 1 0 0	1 1 1 0 0 0 0 0 1 1	1 1 0 1 1 1 0 0 1 1 1	0 1 0 1 0 1 0 1 0	3/4	5/8 3/8	15/16 13/16 11/16 9/16 7/16	LS GF 3/64	7/128 5/128	13/256 11/256 9/256 7/256	CENTER Wi V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.480 4.160 3.840 3.520 3.200 2.880 2.560 2.240 1.920	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.220 0.200 0.180 0.160 0.140 0.120				
F E D C B A 9 8 7 6 5	1 1 1 1 1 1 1 0 0 0 0	1 1 1 0 0 0 0 1 1 1 1	1 1 0 1 1 1 0 0 1 1 1 0	0 1 0 1 0 1 0 1 0 1	3/4	5/8 3/8	15/16 13/16 11/16 9/16 7/16	LS GF 3/64 1/32	7/128 5/128	13/256 11/256 9/256 7/256	CENTER Wi V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.160 3.840 3.520 3.200 2.880 2.560 2.240 1.920 1.600	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.200 0.200 0.180 0.160 0.140 0.120 0.100				
F E D C B A 9 8 7 6 5 4	1 1 1 1 1 1 1 0 0 0 0 0 0	1 1 1 0 0 0 0 1 1 1 1 1	1 1 0 0 1 1 1 0 0 1 1 1 0 0	0 1 0 1 0 1 0 1 0 1 0	3/4	5/8 3/8	15/16 13/16 11/16 9/16 7/16 5/16	LS GF 3/64 1/32	7/128 5/128	13/256 11/256 9/256 7/256 2/256	CENTER Wi V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.160 3.840 3.520 3.200 2.880 2.560 2.240 1.920 1.600 1.280	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.220 0.200 0.200 0.180 0.160 0.140 0.120 0.100 0.080				
F E D C B A 9 8 7 6 5 4 3	1 1 1 1 1 1 1 0 0 0 0 0 0	1 1 1 0 0 0 0 0 1 1 1 1 1 1 0	1 1 0 1 1 1 0 0 1 1 1 0 0 0	0 1 0 1 0 1 0 1 0 1 0 1 0	3/4	5 GROUP 7/8 5/8 3/8	15/16 13/16 11/16 9/16 7/16 5/16	LS GF 3/64 1/32	7/128 5/128 3/128	13/256 11/256 9/256 7/256 2/256	CENTER Wi V _{REF} /2=2 VMS GROUP (Note 15) 4.800 4.480 4.160 3.840 3.520 3.200 2.880 2.560 2.240 1.920 1.600 1.280 0.960	VALUES TH 2.560 V _{DC} VLS GROUP (Note 15) 0.300 0.280 0.260 0.240 0.220 0.220 0.220 0.180 0.160 0.140 0.140 0.120 0.100 0.080 0.060				

Note 15: Display Output=VMS Group + VLS Group

Functional Description (Continued) ► INT (14) **∢ 1/0 WR** (27)* **∢** 1/0 RD (25)* 10k \sim ĊS Vcc O5V иF 2 19 RD CLK R 3 18 WR D B O D B0 (13)* 17 CLK IN DB1 DB1 (16)* 5 16 ĪNT D B 2 DB2 (11)* A/D 6 15 ANALOGO V_{IN(+)} DB3 ► DB3 (9)* 7 14 VIN(-) DB4 DB4 (5)* 8 13 150 pF A GND DB5 DB5 (18)* l=g=I 12 V_{REF}/2 D 86 ► DB6 (20)* 11 D GND 0B7 ► D B7 (7)* ۶v P OUT Vcc Т5 B5 AD15 (36) Т4 B4 **A**D14 (39) DM8131 BUS COMPARATOR ТЗ AD13 (38) B3 T2 B2 AD12 (37) T1 **B**1 🗲 AD11 (40) TO AD10 (1) BO m DS005671-20 Note 16: *Pin numbers for the DP8228 system controller, others are INS8080A. Note 17: Pin 23 of the INS8228 must be tied to +12V through a 1 k Ω resistor to generate the RST 7 instruction when an interrupt is acknowledged as required by the accompanying sample program. FIGURE 12. ADC0801_INS8080A CPU Interface

0038	C3 00 03	RST 7:	JMP L	D DATA
•	•	•		
•	•	•		
0100	21 00 02	START:	TXI H 0500	H ; HL pair will point to
				; data storage locations
0103	31 00 04	RETURN:	LXI SP 040	OH ; Initialize stack pointer (Note 1)
0106	7D		MOVA, L	; Test # of bytes entered
0107	FE OF		CPI OF H	; If $\# = 16.$ JMP to
0109	CA 13 01		JZ CONT	;userprogram
0100	D3 E0		OUT EO H	; Start A/D
010E	FB		EI	;Enable interrupt
010F	00	L00P:	NOP	; Loop until end of
0110	C3 0F 01		JMP LOOP	; conversion
0113	•	CONT:	•	
•	•	•	•	
•	•	(User program to	•	
٠	•	process data)	•	
٠	•	•	•	
•	•	•	•	
0300	DB EO	LD DATA:	IN EO H	; Load data into accumulator
0302	77		MOV M, A	; Store data
0303	23		INXH	; Increment storage pointer
0304	C3 03 01		JMP RETURN	
				DS005671-9

200000

ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

Note 18: The stack pointer must be dimensioned because a RST 7 instruction pushes the PC onto the stack.

Note 19: All address used were arbitrarily chosen.

The standard control bus signals of the 8080 $\overline{\text{CS}}$, $\overline{\text{RD}}$ and $\overline{\text{WR}}$) can be directly wired to the digital control inputs of the A/D and the bus timing requirements are met to allow both starting the converter and outputting the data onto the data bus. A bus driver should be used for larger microprocessor systems where the data bus leaves the PC board and/or must drive capacitive loads larger than 100 pF.

4.1.1 Sample 8080A CPU Interfacing Circuitry and Program

The following sample program and associated hardware shown in *Figure 12* may be used to input data from the converter to the INS8080A CPU chip set (comprised of the INS8080A microprocessor, the INS8228 system controller and the INS8224 clock generator). For simplicity, the A/D is controlled as an I/O device, specifically an 8-bit bi-directional port located at an arbitrarily chosen port address, E0. The TRI-STATE output capability of the A/D eliminates the need for a peripheral interface device, however address decoding is still required to generate the appropriate \overline{CS} for the converter.

It is important to note that in systems where the A/D converter is 1-of-8 or less I/O mapped devices, no address decoding circuitry is necessary. Each of the 8 address bits (A0 to A7) can be directly used as \overline{CS} inputs—one for each I/O device.

4.1.2 INS8048 Interface

The INS8048 interface technique with the ADC0801 series (see *Figure 13*) is simpler than the 8080A CPU interface. There are 24 I/O lines and three test input lines in the 8048. With these extra I/O lines available, one of the I/O lines (bit 0 of port 1) is used as the chip select signal to the A/D, thus eliminating the use of an external address decoder. Bus control signals RD, WR and INT of the 8048 are tied directly to the A/D. The 16 converted data words are stored at on-chip RAM locations from 20 to 2F (Hex). The RD and WR signals are generated by reading from and writing into a dummy address, respectively. A sample interface program is shown below.

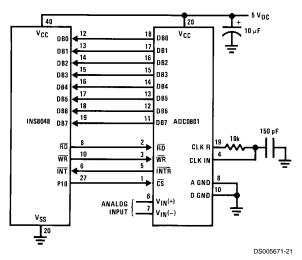


FIGURE 13. INS8048 Interface

SAMPLE PROGRAM FOR Figure 13 INS8048 INTERFACE

04 10		JMP	10H	: Program starts at addr 10
04 50		ORG JMP	3H 50H	; Interrupt jump vector
04 50		ORG	10H	; Main program
		ANL		· • •
99 FE			Pl, #OFEH	; Chip select
81		MOVX	A, @R1	; Read in the 1st data
				; to reset the intr
89 01	START:	ORL	P1, #1	; Set port pin high
B8 20		MOV	RO,#20H	;Data address
B9 FF		MOV	R1, #OFFH	; Dummy address
BA 10		MOV	R2,#10H	; Counter for 16 bytes
23 FF	AGAIN:	MOV	A, #OFFH	; Set ACC for intr loop
99 FE		ANL	Pl, #OFEH	; Send CS (bit 0 of Pl)
91		MOVX	@R1, A	; Send WR out
05		EN	I	;Enable interrupt
96 21	LOOP:	JNZ	LOOP	;Wait for interrupt
EA 1B		DJNZ	R2, AGAIN	; If 16 bytes are read
00		NOP		; go to user's program
00		NOP		
		ORG	50H	
81	INDATA:	MOVX	A. @R1	; Input data, CS still low
ÂÖ		MOV	@RO, A	; Store in memory
18		INC	RO	: Increment storage counter
89 01		ORL	P1,#1	;Reset CS signal
27		CLR	, "_ A	; Clear ACC to get out of
93		RETR	**	; the interrupt loop
				DS005671-A0
				D3003071-A0

4.2 Interfacing the Z-80

The Z-80 control bus is slightly different from that of the 8080. General $\overline{\text{RD}}$ and $\overline{\text{WR}}$ strobes are provided and separate memory request, $\overline{\text{MREQ}}$, and I/O request, $\overline{\text{IORQ}}$, signals are used which have to be combined with the generalized strobes to provide the equivalent 8080 signals. An advantage of operating the A/D in I/O space with the Z-80 is that the CPU will automatically insert one wait state (the $\overline{\text{RD}}$ and $\overline{\text{WR}}$ strobes are extended one clock period) to allow more time for the I/O devices to respond. Logic to map the A/D in I/O space is shown in *Figure 14*.

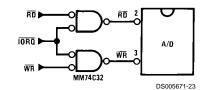


FIGURE 14. Mapping the A/D as an I/O Device for Use with the Z-80 CPU

Additional I/O advantages exist as software DMA routines are available and use can be made of the output data transfer which exists on the upper 8 address lines (A8 to

A15) during I/O input instructions. For example, MUX channel selection for the A/D can be accomplished with this operating mode.

4.3 Interfacing 6800 Microprocessor Derivatives (6502, etc.)

The control bus for the 6800 microprocessor derivatives does not use the $\overline{\text{RD}}$ and $\overline{\text{WR}}$ strobe signals. Instead it employs a single R/W line and additional timing, if needed, can be derived fom the ϕ 2 clock. All I/O devices are memory mapped in the 6800 system, and a special signal, VMA, indicates that the current address is valid. *Figure 15* shows an interface schematic where the A/D is memory mapped in the 6800 system. For simplicity, the $\overline{\text{CS}}$ decoding is shown using $\frac{1}{2}$ DM8092. Note that in many 6800 systems, an already decoded $\frac{4}{5}$ line is brought out to the common bus at pin 21. This can be tied directly to the $\overline{\text{CS}}$ pin of the A/D, provided that no other devices are addressed at HX ADDR: 4XXX or 5XXX.

The following subroutine performs essentially the same function as in the case of the 8080A interface and it can be called from anywhere in the user's program.

In *Figure 16* the ADC0801 series is interfaced to the M6800 microprocessor through (the arbitrarily chosen) Port B of the MC6820 or MC6821 Peripheral Interface Adapter, (PIA). Here the \overline{CS} pin of the A/D is grounded since the PIA is

already memory mapped in the M6800 system and no \overline{CS} decoding is necessary. Also notice that the A/D output data lines are connected to the microprocessor bus under program control through the PIA and therefore the A/D \overline{RD} pin can be grounded.

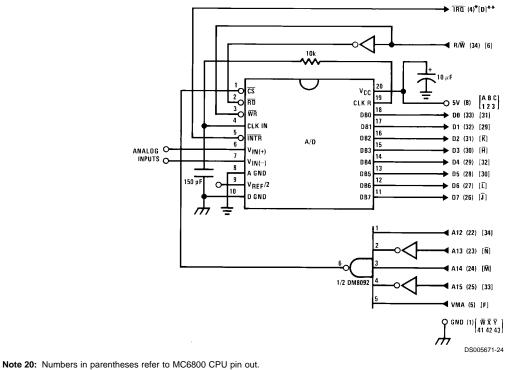
A sample interface program equivalent to the previous one is shown below *Figure 16*. The PIA Data and Control Registers of Port B are located at HEX addresses 8006 and 8007, respectively.

5.0 GENERAL APPLICATIONS

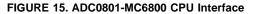
The following applications show some interesting uses for the A/D. The fact that one particular microprocessor is used is not meant to be restrictive. Each of these application circuits would have its counterpart using any microprocessor that is desired.

5.1 Multiple ADC0801 Series to MC6800 CPU Interface

To transfer analog data from several channels to a single microprocessor system, a multiple converter scheme presents several advantages over the conventional multiplexer single-converter approach. With the ADC0801 series, the differential inputs allow individual span adjustment for each channel. Furthermore, all analog input channels are sensed simultaneously, which essentially divides the microprocessor's total system servicing time by the number of channels, since all conversions occur simultaneously. This scheme is shown in *Figure 17*.



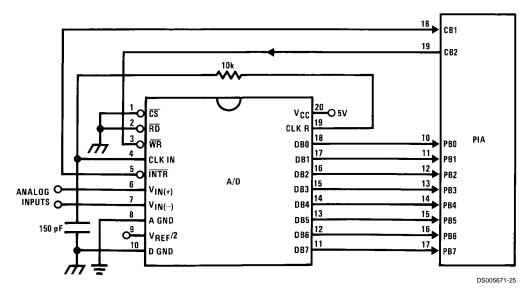
Note 21: Number or letters in brackets refer to standard M6800 system common bus code.

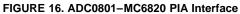


	SAMPLE	PROGRAM FOR	Figure 15 ADC	0801-MC6800 CI	PU INTERFACE
0010	DF 36	DATAIN	STX	TEMP2	; Save contents of X
0012	CE 00 2C		LDX	#\$002C	; Upon IRQ low CPU
0015	FF FF F8		STX	\$FFF8	; jumps to 002C
0018	B7 50 00		STAA	\$5000	; Start ADC0801
001B	OE		CLI		
0010	3E	CONVRT	WAI		;Wait for interrupt
001D	DE 34		LDX	TEMP1	
001F	8C 02 0F		CPX	#\$020F	; Is final data stored?
0022	27 14		BEQ	ENDP	
0024	B7 50 00		STAA	\$5000	;Restarts ADC0801
0027	08		INX		
0028	DF 34		STX	TEMP1	
002A	20 F0		BRA	CONVRT	
0020	DE 34	INTRPT	LDX	TEMP1	
002E	B6 50 00		LDAA	\$5000	; Read data
0031	A7 00		STAA	Х	; Store it at X
0033	3B		RTI		
0034	02 00	TEMPL	FDB	\$0200	; Starting address for
					; data storage
0036	00 00	TEMP2	FDB	\$0000	
0038	CE 02 00	ENDP	LDX	#\$0200	;Reinitialize TEMP1
003B	DF 34		STX	TEMP1	
003D	DE 36		LDX	TEMP2	
003F	39		RIS		; Return from subroutine ; To user's program

DS005671-A1

Note 22: In order for the microprocessor to service subroutines and interrupts, the stack pointer must be dimensioned in the user's program.





ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

Functional Description (Continued)

SAMPLE PROGRAM FOR Figure 16 ADC0801–MC6820 PIA INTERFACE

0010	CE 00 38	DATAIN	LDX	#\$0038	; Upon IRQ low CPU
0013	FF FF F8		STX	\$FFF8	; jumps to 0038
0016	B6 80 06		LDAA	PIAORB	; Clear possible IRQ flags
0019	4F		CLRA		
001A	B7 80 07		STAA	PIACRB	
001D	B7 80 06		STAA	PIAORB	; Set Port B as input
0020	OE		CLI		
0021	C6 34		LDAB	#\$34	
0023	86 3D		LDAA	#\$3D	
0025	F7 80 07	CONVRT	STAB	PIACRB	; Starts ADC0801
0028	B7 80 07		STAA	PIACRB	
002B	3E		WAI		;Wait for interrupt
0020	DE 40		LDX	TEMPL	
002E	8C 02 0F		CPX	#\$020F	; Is final data stored?
0031	27 OF		BEQ	ENDP	
0033	08		INX		
0034	DF 40		STX	TEMPL	
0036	20 ED		BRA	CONVRT	
0038	DE 40	INTRPT	LDX	TEMPL	
003A	B6 80 06		LDAA	PIAORB	;Read data in
003D	A7 00		STAA	Х	;Store it at X
003F	3B		RTI		
0040	02 00	TEMP1	FDB	\$0200	; Starting address for
					; data storage
0042	CE 02 00	ENDP	LDX	#\$0200	;Reinitialize TEMP1
0045	DF 40		STX	TEMPL	
0047	39		RTS		; Return from subroutine
		PIAORB	EQU	\$8006	;To user's program
		PIACRB	EQU	\$8007	
					DS005671-A2

The following schematic and sample subroutine (DATA IN) may be used to interface (up to) 8 ADC0801's directly to the MC6800 CPU. This scheme can easily be extended to allow the interface of more converters. In this configuration the converters are (arbitrarily) located at HEX address 5000 in the MC6800 memory space. To save components, the clock signal is derived from just one RC pair on the first converter. This output drives the other A/Ds.

All the converters are started simultaneously with a STORE instruction at HEX address 5000. Note that any other HEX address of the form 5XXX will be decoded by the circuit, pulling all the $\overline{\text{CS}}$ inputs low. This can easily be avoided by using a more definitive address decoding scheme. All the interrupts are ORed together to insure that all A/Ds have completed their conversion before the microprocessor is interrupted.

The subroutine, DATA IN, may be called from anywhere in the user's program. Once called, this routine initializes the

CPU, starts all the converters simultaneously and waits for the interrupt signal. Upon receiving the interrupt, it reads the converters (from HEX addresses 5000 through 5007) and stores the data successively at (arbitrarily chosen) HEX addresses 0200 to 0207, before returning to the user's program. All CPU registers then recover the original data they had before servicing DATA IN.

5.2 Auto-Zeroed Differential Transducer Amplifier and A/D Converter

The differential inputs of the ADC0801 series eliminate the need to perform a differential to single ended conversion for a differential transducer. Thus, one op amp can be eliminated since the differential to single ended conversion is provided by the differential input of the ADC0801 series. In general, a transducer preamp is required to take advantage of the full A/D converter input dynamic range.

ADC0801/ADC0802/ADC0803/ADC0804/ADC0805

Functional Description (Continued) R/W (34)[#][6]** DATA BUS DO (33) [31] 51k D1 (32) [29] D2 (31) [K] D3 (30) [Ĥ] Vcc 19 \bigcirc ĊS D4 (29) [32] RD CLK R D5 (28) [30] 18 WR DBO D6 (27) [Ī] 17 CLK IN DB1 07 (26) $[\overline{J}]$ 5 16 INTR D 82 A/D 6 15 ANALOG O (IN(+) DB3 7 14 🖣 A2 (11) [Ŭ] VIN(--) D 84 8 30 p 13 🖣 A1 (10) [V] A GND O 85 م 10 12 🕇 A0 (9) [40] V_{REF}/2 D B6 11 D GND D B7 ÷ O 5V (8) A B C 1 Z 3 15 YO •••• . • . G DM74LS138 ¢1 ◀ ◘R (3) 禄2 G2A . • ¥7 G2B ĥ • ٠ IRQ (4) [D] CS vcc 19 RD CLK R 18 WR DBO 4 CLK IN DB1 O GND (1) $\begin{bmatrix} \overline{W} \ \overline{X} \ \overline{Y} \\ 41 \ 42 \ 43 \end{bmatrix}$ 5 ÍŇŤR D 82 A/D ᠊ᡯ 6 15 ANALDG O VIN(+) DB3 7 14 DB4 VIN(--) 8 13 A GND D 85 9 12 V_{REF}/2 D B6 VMA (5) [F] 10 11 D GND DB7 A12 (22) [34] m 🕇 A13 (23) [N] 1/2 DM8092 A14 (24) [M] 🖣 A15 (25) [33] DS005671-26 Note 23: Numbers in parentheses refer to MC6800 CPU pin out. Note 24: Numbers of letters in brackets refer to standard M6800 system common bus code. FIGURE 17. Interfacing Multiple A/Ds in an MC6800 System

SAM	MPLE PROGRAM FOR	R Figure 17 IN		MULTIPLE A/C	O'S IN AN MC6800 SYSTEM
ADDRESS	HEX CODE		MNEMONICS		COMMENTS
0010	DF 44	DATAIN	STX	TEMP	; Save Contents of X
0012	CE 00 2A		LDX	#\$002A	; Upon IRQ LOW CPU
0015	FF FF F8		STX	\$FFF8	; Jumps to 002A
0018	B7 50 00		STAA	\$5000	;Starts all A/D's
001B	OE		CLI		
0010	3E		WAI		;Wait for interrupt
001D	CE 50 00		LDX	#\$5000	
0020	DF 40		STX	INDEX1	; Reset both INDEX
0022	CE 02 00		LDX	#\$0200	; 1 and 2 to starting
0025	DF 42		STX	INDEX2	; addresses
0027	DE 44		LDX	TEMP	
0029	39		RTS		;Return from subroutine
002A	DE 40	INTRPT	LDX	INDEX1	; INDEX1 \rightarrow X
0020	A6 00		LDAA	Х	;Read data in from A/D at X
002E	08		INX		; Increment X by one
002F	DF 40		STX	INDEX1	$; X \rightarrow INDEX1$
0031	DE 42		LDX	INDEX2	; INDEX2 \rightarrow X

DS005671-A3

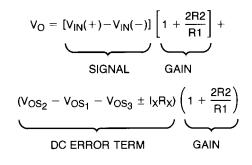
SAMPLE PROGRAM FOR Figure 17 INTERFACING MULTIPLE A/D's IN AN MC6800 SYSTEM

ADDRESS	HEX CODE	N	NEMONIC	S	COMMENTS
0033	A7 00		STAA	Х	; Store data at X
0035	80 02 07		CPX	#\$0207	;Have all A/D's been read?
0038	27 05		BEQ	RETURN	;Yes: branch to RETURN
003A	08		INX		; No : increment X by one
003B	DF 42		STX	INDEX2	$; X \rightarrow INDEX2$
003D	20 EB		BRA	INTRPT	; Branch to 002A
003F	3B	RETURN	RTI		
0040	50 00	INDEX1	FDB	\$5000	; Starting address for A/D
0042	02 00	INDEX2	FDB	\$0200	; Starting address for data storage
0044	00 00	TEMP	FDB	\$0000	

DS005671-A4

Note 25: In order for the microprocessor to service subroutines and interrupts, the stack pointer must be dimensioned in the user's program.

For amplification of DC input signals, a major system error is the input offset voltage of the amplifiers used for the preamp. *Figure 18* is a gain of 100 differential preamp whose offset voltage errors will be cancelled by a zeroing subroutine which is performed by the INS8080A microprocessor system. The total allowable input offset voltage error for this preamp is only 50 μ V for 1/4 LSB error. This would obviously require very precise amplifiers. The expression for the differential output voltage of the preamp is:



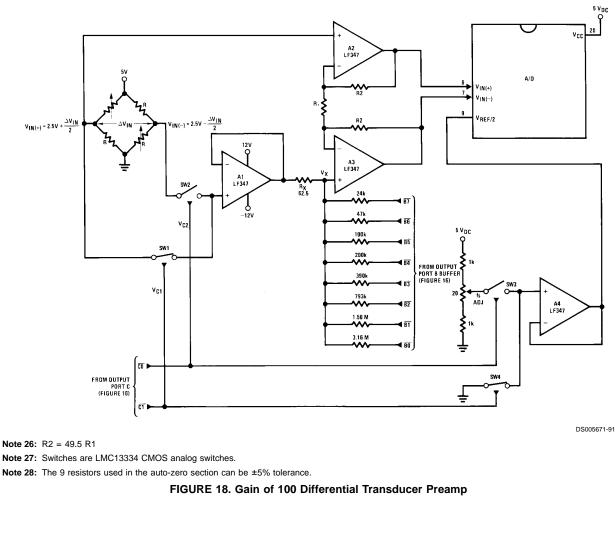
where $I_{\rm X}$ is the current through resistor $R_{\rm X}.$ All of the offset error terms can be cancelled by making $\pm I_{\rm X}R_{\rm X}{=}~V_{\rm OS1}$ + $V_{\rm OS3}$ – $V_{\rm OS2}.$ This is the principle of this auto-zeroing scheme.

The INS8080A uses the 3 I/O ports of an INS8255 Programable Peripheral Interface (PPI) to control the auto zeroing and input data from the ADC0801 as shown in *Figure 19*. The PPI is programmed for basic I/O operation (mode 0) with Port A being an input port and Ports B and C being output ports. Two bits of Port C are used to alternately open or close the 2 switches at the input of the preamp. Switch SW1 is closed to force the preamp's differential input to be zero during the zeroing subroutine and then opened and SW2 is then closed for conversion of the actual differential input signal. Using 2 switches in this manner eliminates concern for the ON resistance of the switches as they must conduct only the input bias current of the input amplifiers.

Output Port B is used as a successive approximation register by the 8080 and the binary scaled resistors in series with each output bit create a D/A converter. During the zeroing subroutine, the voltage at V_x increases or decreases as required to make the differential output voltage equal to zero. This is accomplished by ensuring that the voltage at the output of A1 is approximately 2.5V so that a logic "1" (5V) on

any output of Port B will source current into node V_X thus raising the voltage at V_x and making the output differential more negative. Conversely, a logic "0" (0V) will pull current out of node V_X and decrease the voltage, causing the differential output to become more positive. For the resistor values shown, V_X can move ±12 mV with a resolution of 50 μ V, which will null the offset error term to 1/4 LSB of full-scale for

the ADC0801. It is important that the voltage levels that drive the auto-zero resistors be constant. Also, for symmetry, a logic swing of 0V to 5V is convenient. To achieve this, a CMOS buffer is used for the logic output signals of Port B and this CMOS package is powered with a stable 5V source. Buffer amplifier A1 is necessary so that it can source or sink the D/A output current.



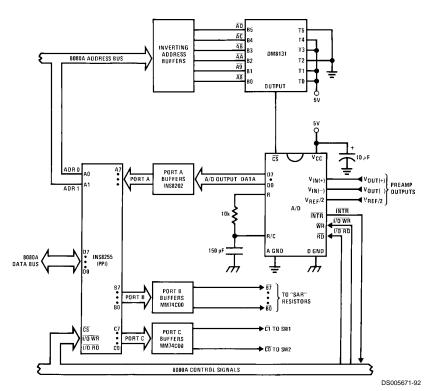


FIGURE 19. Microprocessor Interface Circuitry for Differential Preamp

A flow chart for the zeroing subroutine is shown in *Figure 20*. It must be noted that the ADC0801 series will output an all zero code when it converts a negative input $[V_{\rm IN}(-) \geq V_{\rm IN}(+)]$. Also, a logic inversion exists as all of the I/O ports are buffered with inverting gates.

Basically, if the data read is zero, the differential output voltage is negative, so a bit in Port B is cleared to pull V_x more negative which will make the output more positive for the next conversion. If the data read is not zero, the output voltage is positive so a bit in Port B is set to make V_x more positive and the output more negative. This continues for 8 approximations and the differential output eventually converges to within 5 mV of zero.

The actual program is given in *Figure 21*. All addresses used are compatible with the BLC 80/10 microcomputer system. In particular:

Port A and the ADC0801 are at port address E4

Port B is at port address E5

Port C is at port address E6

PPI control word port is at port address E7

Program Counter automatically goes to ADDR:3C3D upon acknowledgement of an interrupt from the ADC0801

5.3 Multiple A/D Converters in a Z-80 Interrupt Driven Mode

In data acquisition systems where more than one A/D converter (or other peripheral device) will be interrupting program execution of a microprocessor, there is obviously a need for the CPU to determine which device requires servicing. *Figure 22* and the accompanying software is a method of determining which of 7 ADC0801 converters has completed a conversion (INTR asserted) and is requesting an interrupt. This circuit allows starting the A/D converters in any sequence, but will input and store valid data from the converters with a priority sequence of A/D 1 being read first, A/D 2 second, etc., through A/D 7 which would have the lowest priority for data being read. Only the converters whose INT is asserted will be read.

The key to decoding circuitry is the DM74LS373, 8-bit D type flip-flop. When the Z-80 acknowledges the interrupt, the program is vectored to a data input Z-80 subroutine. This subroutine will read a peripheral status word from the DM74LS373 which contains the logic state of the INTR outputs of all the converters. Each converter which initiates an interrupt will place a logic "0" in a unique bit position in the status word and the subroutine will determine the identity of the converter and execute a data read. An identifier word (which indicates which A/D the data came from) is stored in the next sequential memory location above the location of the data so the program can keep track of the identity of the data entered.

Functional Description (Continued)

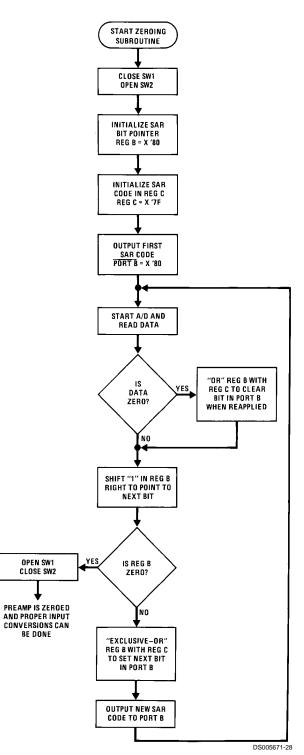


FIGURE 20. Flow Chart for Auto-Zero Routine

Functional Description (Continued)

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3D00	3E90	MVI 90		
3D02	D3E7	Out Control Port		; Program PPI
3D04	2601	MVIHOL	Auto-Zero Subroutine	-
3D06	7C	MOV A, H		
3D07	D3E6	OUT C		;Close SW1 open SW2
3D09	0680	MVI B 80		; Initialize SAR bit pointer
3D0B	3E7F	MVIA7F		: Initialize SAR code
3D0D	<b>4</b> F	MOV C,A	Return	,
3D0E	D3E5	OUTB		; Port B = SAR code
3D10	31AA3D	LXI SP 3DAA	Start	; Dimension stack pointer
3D13	D3E4	OUT A		; Start A/D
3D15	FB	IE		, , -
3D16	00	NOP	Loop	; Loop until INT asserted
3D17	C3163D	JMP Loop	F	,
3D1A	7A	MOV A, D	Auto-Zero	
3D1B	C600	ADI 00		
3D1D	CA2D3D	JZ Set C		; Test A/D output data for zero
3D20	78	MOV A, B	Shift B	, rost A/D output data for 2010
3D21	F600	ORI 00		; Clear carry
3D23	1F	RAR		; Shift "1" in Bright one place
3D24	FEOO	CPI 00		; Is B zero? If yes last
3D26	CA373D	JZ Done		; approximation has been made
3D29	47	MOV B.A		, approximation has been made
3D2A	C3333D	JMP New C		
3D2D	79	MOV A.C	Set C	
3D2E	BO	ORA B	5666	;Set bit in C that is in same
3D2F	4F	MOV C, A		; position as "1" in B
3D30	C3203D	JMP Shift B		, position as in in b
3D33	A9	XRA C	New C	;Clear bit in C that is in
3D34	C30D3D	JMP Return	110 W C	; same position as "1" in B
3D37	47	MOV B, A	Done	; then output new SAR code.
3D38	7C	MOV A,H	Done	; Open SW1, close SW2 then
3D39	EE03	XRI 03		; proceed with program. Preamp
3D3B	D3E6	OUT C		; is now zeroed.
3D3D	DOLO	•	Normal	; 15 How 20roed.
0000		•	Normat	
		Program for processing		
		proper data values		
3C3D	DBE4	IN A	Read A/D Subroutine	· Pood & /D dot o
3C3F	EEFF	XRI FF	Neau M/D Subroutine	; Read A/D data
303F 3041	57	MOV D,A		; Invert data
3041	57 78	MOV D, A MOV A, B		
3042	E6FF	ANI FF		; Is B Reg = 0? If not stay
3045	C21A3D	JNZ Auto-Zero		; in auto zero subroutine
3045	C33D3D	JMP Normal		
0040	000000	JHI HUIHAL		DS005671-A5

Note 29: All numerical values are hexadecimal representations.

#### FIGURE 21. Software for Auto-Zeroed Differential A/D

# 5.3 Multiple A/D Converters in a Z-80 Interrupt Driven Mode (Continued)

The following notes apply:

- It is assumed that the CPU automatically performs a RST 7 instruction when a valid interrupt is acknowledged (CPU is in interrupt mode 1). Hence, the subroutine starting address of X0038.
- The address bus from the Z-80 and the data bus to the Z-80 are assumed to be inverted by bus drivers.
- A/D data and identifying words will be stored in sequential memory locations starting at the arbitrarily chosen address X 3E00.
- The stack pointer must be dimensioned in the main program as the RST 7 instruction automatically pushes the PC onto the stack and the subroutine uses an additional 6 stack addresses.
- The peripherals of concern are mapped into I/O space with the following port assignments:

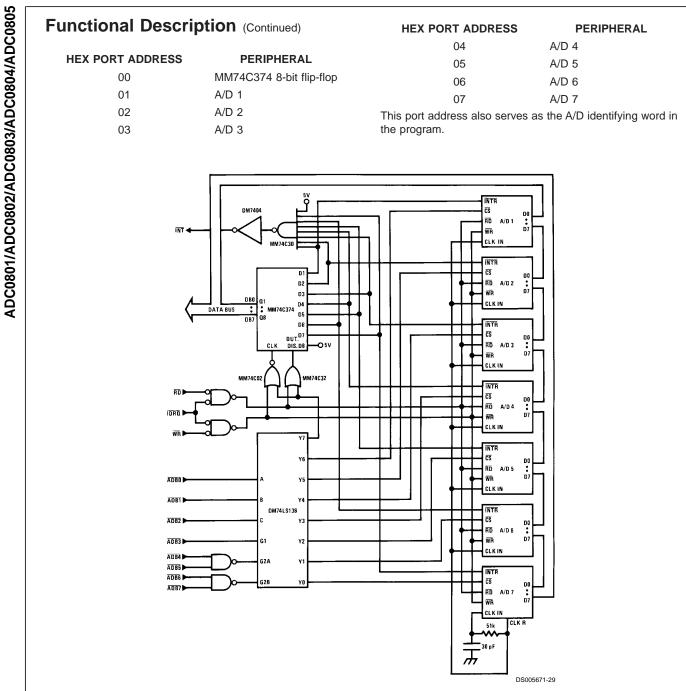


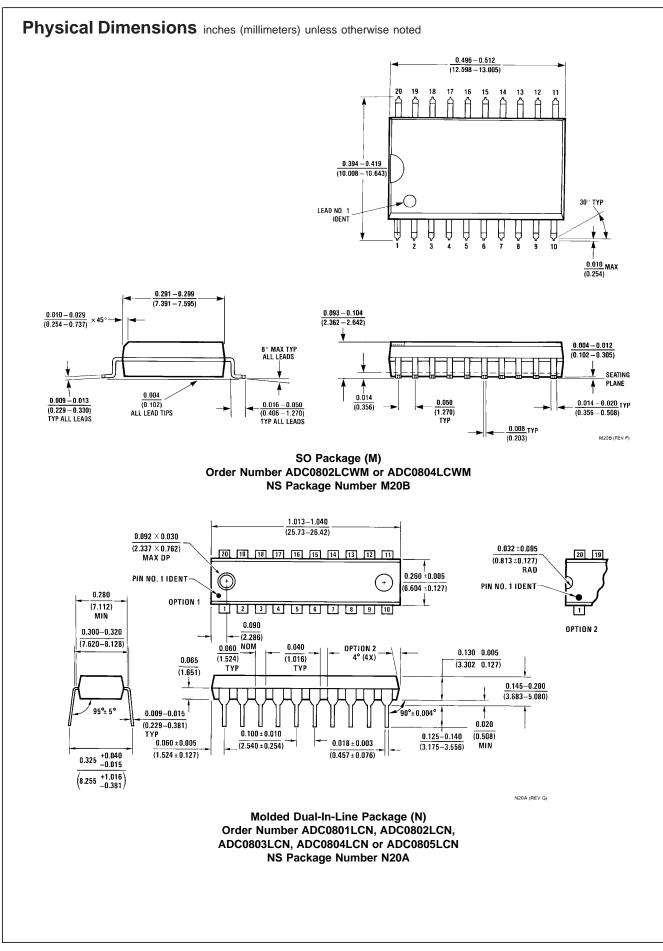
FIGURE 22. Multiple A/Ds with Z-80 Type Microprocessor

# Functional Description (Continued)

#### INTERRUPT SERVICING SUBROUTINE

			SOURCE	
LOC	OBJ CODE		STATEMENT	COMMENT
0038	E5		PUSH HL	; Save contents of all registers affected by
0039	C5		PUSH BC	; this subroutine.
003A	F5		PUSH AF	;Assumed INT mode learlier set.
003B	21 00 3E		LD (HL),X3E00	; Initialize memory pointer where data will be stored.
003E	0E 01		LDC,XO1	; C register will be port ADDR of A/D converters.
0040	D300		OUT XOO, A	; Load peripheral status word into 8-bit latch.
0042	DBOO		IN A, XOO	; Load status word into accumulator.
0044	47		LD B,A	; Save the status word.
0045	79	TEST	LD A, C	; Test to see if the status of all A/D's have
0046	FE 08		CP, X08	; been checked. If so, exit subroutine
0048	CA 60 00		JPZ, DONE	
004B	78		LD A, B	; Test a single bit in status word by looking for
004C	lF		RRA	; a "l" to be rotated into the CARRY (an INT
004D	47		LD B,A	; is loaded as a "l"). If CARRY is set then load
004E	DA 5500		JPC, LOAD	; contents of A/D at port ADDR in C register.
0051	OC	NEXT	INC C	; If CARRY is not set, increment C register to point
0052	C3 4500		JP,TEST	; to next A/D, then test next bit in status word.
0055	ED 78	LOAD	INA, (C)	; Read data from interrupting A/D and invert
0057	EE FF		XOR FF	; the data.
0059	77		LD (HL),A	; Store the data
005A	20		INC L	
005B	71		LD (HL),C	; Store A/D identifier (A/D port ADDR).
005C	20		INC L	
005D	C3 51 00		JP,NEXT	; Test next bit in status word.
0060	Fl	DONE	POP AF	;Re-establish all registers as they were
0061	Cl		POP BC	; before the interrupt.
0062	El		POP HL	-
0063	C9		RET	;Return to original program

DS005671-A6



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# **ADC0803 Product Folder**

# 8-Bit µP Compatible A/D Converters

See Also: <u>ADC0801</u> - improved conversion accuracy

GeneralDescription	res Datasheet	<u>Package</u> <u>&amp; Models</u>	<u>Samples</u> <u>&amp; Pricing</u>	<u>Application</u> <u>Notes</u>
Parametric Table		Parametric Table		
On-Board Reference	No	Input Multiplexer		1
Resolution	8 bits	Digital Interface	Parallel	
Conversion Time (us)	100	Software Powerdown	n	No
Differential Input	Yes	Onboard Controller		No
Input Sample/Hold	No	Conversion Accuracy	y (LSB)	.5
2	<u>,</u>	Power Supply Voltag	ge (Volts)	5.0

#### Datasheet

Title	Size in Kbytes	Date	View Online	Download	Receive via Em a il
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#### Package Availability, Models, Samples & Pricing

Part Number	Package		Status	Models		Samples & Electronic	Budgetary Pricing		Std Pack	<u>Package</u> Marking	
	Туре	Pins	MSL		SPICE	IBIS	Orders	Qty	\$US each	Size	
ADC0803LCN	MDIP	20	<u>MS L</u>	Full production	N/A	N/A	24 Hour Buy Now	1 K+	\$2.3600	rail of 18	[logo]¢U¢Z¢3¢T¢P ADC0803LCN

ADC0803 MDC	Die	Full production	N/A	N/A	Samples	gel pak of N/A	-
ADC0803 MWC	<u>Wafer</u>	Full production	N/A	N/A		wafer jar of N/A	-

#### General Description

The ADC0801, ADC0802, ADC0803, ADC0804 and ADC0805 are CMOS 8-bit successive approximation A/D converters that use a differential potentiometric ladder-similar to the 256R products. These converters are designed to allow operation with the NSC800 and INS8080A derivative control bus with TRI-STATE output latches directly driving the data bus. These A/Ds appear like memory locations or I/O ports to the microprocessor and no interfacing logic is needed.

Differential analog voltage inputs allow increasing the common-mode rejection and offsetting the analog zero input voltage value. In addition, the voltage reference input can be adjusted to allow encoding any smaller analog voltage span to the full 8 bits of resolution.

#### Features

- Compatible with 8080 µP derivatives-no interfacing logic needed access time 135 ns
- Easy interface to all microprocessors, or operates "stand alone"
- Differential analog voltage inputs
- Logic inputs and outputs meet both MOS and TTL voltage level specifications
- Works with 2.5V (LM336) voltage reference
- On-chip clock generator
- 0V to 5V analog input voltage range with single 5V supply
- No zero adjust required
- 0.3[Prime] standard width 20-pin DIP package
- 20-pin molded chip carrier or small outline package
- Operates ratiometrically or with 5  $V_{DC}$ , 2.5  $V_{DC}$ , or analog span adjusted voltage reference

#### Key Specification

Resolution	8 bits
Total error	$\pm \frac{1}{4}$ LSB, $\pm \frac{1}{2}$ LSB and $\pm 1$ LSB
Conversion time	100 µs

#### Application Notes

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# **ADC0804 Product Folder**

# 8-Bit µP Compatible A/D Converters

See Also: <u>ADC0802</u> - improved conversion accuracy

<u>General</u> <u>Description</u> <u>Features</u>	<u>Datasheet</u>	PackageSamples& Models& Pricing	<u>Application</u> <u>Notes</u>
Parametric Table		Parametric Table	
On-Board Reference	No	Input Multiplexer	1
Resolution	8 bits	Digital Interface	Parallel
Conversion Time (us)	100	Software Powerdown	No
Differential Input	Ye s	Onboard Controller	No
Input Sample/Hold	No	Conversion Accuracy (LSB)	1
-	· · · ·	Power Supply Voltage (Volts)	5.0

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ADC0804LCWM	<u>SOIC</u> <u>WIDE</u>	20	MS L	Full production	N/A	N/A	24 Hour Buy Now	1 K+	\$1.2100	rail of 36	[logo]¢U¢Z¢2¢T ADC0804 LCWM

ADC0804LCWMX	SOIC WIDE	20	MS L	Full production	N/A	N/A	Buy Now	1 K+	\$1.2100	reel of 1000	[logo]¢U¢Z¢2¢T ADC0804 LCWM
ADC0804LCN	MDIP	20	MSL	Full production	N/A	N/A	Buy Now	1 K+	\$1.2600	rail of 18	[logo]¢U¢Z¢3¢T¢P ADC0804LCN
ADC0804LCJ	CERDIP	20	MS L	Full production	N/A	N/A	Buy Now	500+	\$3.0600	rail of 20	[logo]¢U¢Z¢3¢T¢P ADC0804LCJ
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ADC0804 MWC	<u>Wafer</u>		Full production	N/A	N/A				wafer jar of N/A	-	

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